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Letter Report

On the Issue of Noble Metals in the DWPF Melter

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Acronyms and Abbreviations

CETL: Clemson Environmental Technologies Laboratory

DWPF: Defense Waste Processing Facility
EDAX: Energy Dispersive Analysis by X-Ray

ESM: Engineering Scale Melter

HEWC: High Enrichment Waste Concentrate

HWVP1: First Run of the HWVP Process Demonstration
 HWVP2: Second Run of the HWVP Process Demonstration
 HWVP: The former Hanford Waste Vitrification Plant Project

IDMS: Integrated DWPF Melter System

INE/KfK: Institute für Nuklear Entsorgungstechnik at Kernforshungzentrum

Karlsruhe (Nuclear Fuel Cycle Center)

LEWC: Low Enrichment Waste Concentrate
NCAW: Neutralized Current Acid Waste

PNNL: Pacific Northwest National Laboratory

RSM: Research Scale Melter (at PNNL)

SEM: Scanning Electron Microscopy/Microscope

SRS: Savannah River Site

SRTC: Savannah River Technology Center
TVF: Tokai Vitrification Facility (Japan)

WAK: Waste from the Karlsruhe Reprocessing Plant
WSRC: Westinghouse Savannah River Company
WVDP: West Valley Demonstration Project

XRD: X-Ray Diffraction

1.0 Summary and Recommendations for DWPF

1.1 Summary

The fission-product noble metals (Ru, Rh, and Pd), their alloys and compounds tend to settle to the floor of Joule-heated ceramic melters that are used for High Level Waste (HLW) vitrification. An accumulation of these dense, conductive and highly viscous materials can adversely affect the melter operation by decreasing the power release and distribution in the bulk glass in the melter. This can decrease the feed throughput capacity and diminish the melter's ability to maintain the desired operating temperature. This conductive layer can also cause non-uniform and uncontrollable current distributions at the surface of the electrodes that can lead to physical damage or failure of the electrodes.

The DWPF has been in radioactive operation since 1996 and will soon begin feeding a new sludge with concentrations of noble metals that are higher than have been processed to date. Table 1-1 gives the predicted noble metal concentrations for HM, PUREX and Blend sludges (a hypothetical blending of PUREX and HM). Also listed are measured values for Tank 51 (sludge batch 1A, macrobatch 1), and for Tank 40, the next sludge batch to the DWPF. The values for Tank 40 represent the minimum (as received) and maximum (overwashed) bounding values for these components (Fellinger and Bibler, 2001). The values for Tank 40 indicate a significant increase in the expected values of Ru and Rh (the noble metals that tend to be retained in the melter in the highest percentages) over that of Tank 51.

Table 1-1. Predicted and Measured Noble Metal Concentrations in Various Savannah River Sludges

	Blend	НМ	PUREX	Tank 51 SB-1A	Tank 40 Measured	
Element	Predicted wt-%	Predicted wt-%	Predicted wt-%	Measured (as received) (ov wt-% wt-%		(overwashed) wt-%
Ru	0.100	0.217	0.028	0.007	0.019	0.042
Rh	0.018	0.038	0.008	0.001	0.005	0.010
Pd	0.045	0.079	0.026	0.006	0.001	0.001
Ag	0.014	0.014	0.014	0.014	0.007	0.015

(wt-% of the total sludge solids, soluble and insoluble)

The ratio of upper-to-lower melt resistances was used during the operation of the Integrated DWPF Melter System (IDMS) as an indication of noble metal accumulation. During the time period from July 2000 to December 2000, the monthly average ratio of upper-to-lower melt apparent resistance in the DWPF melter increased from 1.02 to 1.60. This is shown in Figure 1-1.

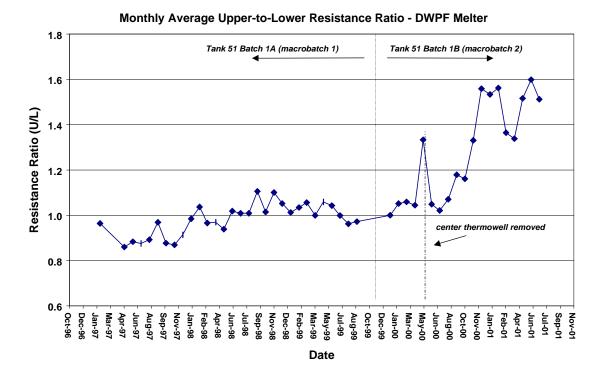


Figure 1-1. Monthly Average Upper-to-Lower Resistance Ratio for the DWPF Melter

There are operational changes, however, that must be considered in evaluating this data. In November 1999, a new sludge macrobatch (Tank 51 sludge 1B, macrobatch 2) was introduced. This sludge was higher in aluminum than the previous macrobatch had been. This resulted in a more viscous molten glass and possibly less convection in the melter. Also, in May 2000 a thermowell with three thermocouples was removed from the center of the melter. The average lower glass pool temperature abruptly dropped at that time since it was then the average of only three thermocouple readings in a thermowell located near the outer edge of the melter wall (a colder region of the melt pool). So, the change in the resistance ratio is, at least partially, due to this artificial drop in the lower glass temperature (and a corresponding increase in the upper glass temperature). Prior to May 2000, the average lower glass pool temperature, which at that time was an average of six thermocouple readings (three in the center of the melter and three at the outer edge of the melt pool), consistently ran from 1100 to 1120 °C. The average upper glass pool temperature was typically between 1140 and 1170 °C. However, after May 2000, the monthly average temperature (of just the three outer edge thermocouple readings) for the lower glass pool has ranged from 1060 to 1080 °C. In the early periods of radioactive operation, the amount of current supplied to the upper set of electrodes was typically about the same or slightly more than that supplied to the lower set (sometimes as much as 25% more). In June 2000 the amount of current supplied to the respective electrodes began to diverge, increasing from 916 to 1226 amps for the lower electrodes and decreasing from 923 to 729 amps for the upper electrodes (monthly averages between June 2000 and July 2001).

This divergence has been linked to electrical shorting outside of the melter, caused by a dropped connector shorting the lower electrode bus bars. The resistance ratio was restored when the dropped connector was removed. Therefore, while the trend is not attributed to noble metals, the use of the ratio of the electrical impedance of the electrodes has been demonstrated to be effective as a means of monitoring melter conditions with respect to electrical shorting, as has been previously proposed (Bickford, et. al., 1988) and substantiated during IDMS melter operations (I.G. Choi, et. al., 1993).

During testing in the Savannah River Technology Center's (SRTC) Integrated DWPF Melter System (IDMS), a pilotscale facility at the TNX area that operated from 1988 - 1995, significant amounts of Ru (as RuO₂) and Rh settled to the melter floor. Often these noble metals were associated with spinel crystals (as nucleating agents or as isomorphic substitution in the crystal lattice or both). The electrical response of the DWPF melter is similar to observations made during the operation of the IDMS melter. Similar to that observed in the DWPF, the resistance ratio for the IDMS melter was initially stable, oscillating from 1.1 to 1.3. However, after 550 days of operation with noble metals the resistance ratio increased dramatically and continued upward, over time, to 2.3 - 2.5. The sudden increase in the resistance ratio corresponded to a time when melter floor samples revealed a significant increase in the amount of material on the melter floor. Upon close examination of the data (plots are presented in Smith and Bickford, 1997), it appears that the IDMS upper-to-lower resistance ratio increased largely because of an increase in the apparent resistance in the upper glass pool. The lower glass pool resistance did have a gradual drop during a 100-day period of operation (during days 500 to 600 of operation) when the lower glass pool resistance declined from the nominal 0.10 ohms to about 0.06 ohms. It remained at about 0.06 to 0.07 ohms for the remainder of the operation. The upper glass pool resistance also declined during the same 100-day period, from the initial 0.12 down to about 0.10. It then decreased to about 0.08 before beginning a steady increase up to approximately 0.15 ohms. In contrast, the DWPF melter has not had a sustained decrease in the lower melt pool resistance. The monthly average upper and lower glass pool resistances for the DWPF melter are shown in Figure 1-2. Operational significant effects are also shown on the plot.

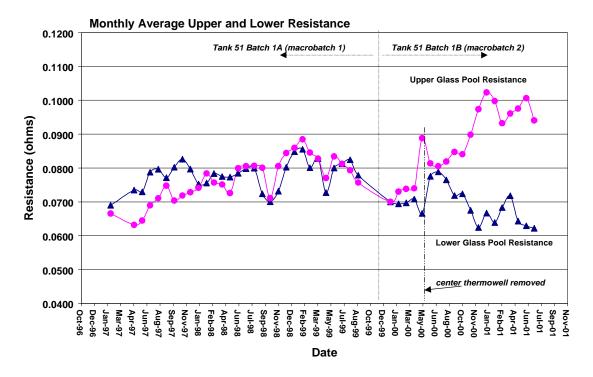


Figure 1-2. DWPF Melter Monthly Average Upper and Lower Glass Pool Resistances

Samples taken from the IDMS melter floor suggested the accumulation of an uneven (with respect to concentration), viscous, and relatively conductive layer. However, the layer did not seem to be continuous. The accumulated noble metals and noble metal oxides seemed to be somewhat uniformly dispersed within dense accumulations of spinel crystals. Eventually, due to the accumulation of conductive material, a lower electrode current density of approximately 6.1 amps/in² (compared to the design value of 5.0 amps/in²) was required to maintain the lower glass pool at 1070°C. Note: The DWPF electrodes have consistently operated well below the 5.0 amps/in² design value.

The IDMS melter was maintained at the operating temperature of approximately 1070 to 1150 °C; however, it was not continuously fed and experienced many idle periods (*i.e.*, no feeding). Analytical results from the IDMS runs suggested that the majority of the noble metals that settled in the IDMS melter did so during these idling periods. It is thought that the convection currents that are present during slurry feeding (driven by the cold slurry layer on the molten pool known as the "cold cap" and the temperature drop (Δ T)) were sufficient to keep the noble metal particles suspended. The suspended noble metals then exited the melter as inclusions in the glass product. However, during extended idling periods, the convection currents were relatively minor (no cold cap coverage). The noble metal particles then settled over time in the stagnant molten glass pool. From the IDMS experience, it was recommended that the DWPF limit the number of idling periods (Smith and Bickford, 1997), and the DWPF melter has experienced relatively few periods of extended idling during its operation. Because of the much larger inner diameter, the convection currents in the DWPF melter are expected to be much lower (There are other factors, e.g., Δ T, melter

geometry, feed processing, and redox that contribute to this). Also, the high pour rate and small internal diameter of the IDMS melter may have helped to increase the amount of noble metals that were pulled out through the riser.

The SRS Tank 51 sludge that has been fed to the DWPF melter has been very low in noble metals concentration, much lower than was tested in the IDMS melter (see Table 1-1). The melter has experienced relatively few periods of extended idling. And now the DWPF is preparing to begin processing of a new batch of sludge that is higher in noble metals. Most studies have indicated that the amount of noble metals that settle to the melter floor is greatly influenced by: 1) the concentration of the noble metals in the melt, 2) the size, shape and chemical state of the noble metals, and 3) the amount of mixing in the melter. The next sludge batch, from SRS Tank 40, is 2.7 to 6 times higher in Ru than that of Tank 51-1A (Tank 51 sludge 1A, macrobatch 1). The Rh concentration is 5 to 10 times higher in Tank 40 than in Tank 51-1A. Note: The concentration of each depends on the degree of washing. The SRS sludge is washed to remove excess aluminum and sodium. The lower value represents the "no washing" extreme and the upper value represents the "overwashed" extreme. In Research Scale Melter (RSM) studies at PNNL, the results suggested that there was a significant nonlinear increase in the amount of noble metal compounds deposited on the melter floor. With a 2-fold increase in the nominal noble metal content of the NCAW melter feed simulant there was a corresponding 9fold increase in the fraction settling to the RSM floor (Cooper et al., 1994). The NCAW noble metals content is much closer to that of the SRS HM sludge, which is much higher than will be processed from Tank 40. So, the amount of noble metals that settle from that glass melt may not be 9-fold over that from Tank 51-1A, but, it is likely that there will be some nonlinear increase in noble metals settling from Tank 40 melter feed over that from the Tank 51-1A melter feed.

1.2 Recommendations

It is difficult to determine, with sufficient confidence, whether the DWPF melter has a deposition of noble metals on the floor It is difficult to separate the complex and often competing effects of the waste composition, the glass pool temperatures, and the varying operating conditions. And, while many of the electrical characteristics are similar to those observed in the IDMS melter (as a result of noble metals deposition), there has been no appreciable change in the lower melt resistance in the DWPF melter, the initial indication of deposition in the IDMS melter.

Recommendation #1. It is extremely difficult to diagnose the extent of noble metal deposition in the DWPF melter. It is also, at this point, impossible to reliably forecast the long or short-term effects if there is accumulations. Nonetheless, it seems prudent to ensure that well thought out plans and procedures are in place in the event of an acute or protracted melter failure.

Recommendation #2. The DWPF should continue to monitor the ratio of the upper-to-lower melt pool resistance as one indication of accumulation of conductive material. The monthly average should be trended with time. The individual circuit resistances should also be routinely monitored and trended with time. Operational characteristics, current and/or power input, glass pool temperatures, etc. should also be monitored routinely and trended. A detailed examination of the historical data is recommended.

Recommendation #3. The operation of the center thermowell should be restored to provide a more complete temperature profile of the melter.

Recommendation #4. The DWPF has, to date, processed sludge with a relatively low noble metals content. Future sludge batches, such as that in Tank 40, will have higher noble metal content. Because of this, evaluations of alternative melter technologies that are not as susceptible to the effects of deposition of the insoluble noble metals should be supported (e.g., induction cold crucible melter, ICCM).

Recommendation #5. In the event of noble metal accumulation, it may be possible to affect the resulting electrical distortions in the melter by disturbing the viscous spinel/noble metal layer. The DWPF should consider means, such as air sparging, by which a sludge layer may be disrupted The use of tools that may be available or may be engineered to dislodge and redistribute deposits of noble metals and spinel crystals in situ should also be considered.

Recommendation #6. The DWPF should consider collecting a representative sample of any accumulated material on the melter floor during extended outages between sludge batches.

Recommendation #7. Artificial intelligence programs should be used to analyze the historic melter data and determine if they can be used to monitor melter deterioration. This will decrease the risk of locally overheating melter components.

Recommendation #8. Agitation of the DWPF melt pool should be considered as a means of keeping noble metals in suspension, as well as other positive effects such as increased melt rate.

2.0 Background

Numerous governments worldwide have committed to stabilization of high-level nuclear waste (HLW) using vitrification. Many of the facilities use the Joule-heated ceramic melter as the means of stabilizing the high-level nuclear waste in a glass matrix. These facilities include:

- the German PAMELA facility in Mol, Belgium;
- the Tokai Vitrification Facility (TVF) in Tokai, Japan;
- the Defense Waste Processing Facility (DWPF) at the Savannah River Site in Aiken, SC;
- the West Valley Demonstration Project (WVDP) in West Valley, NY; and
- the planned Waste Treatment Plant (WTP) at the Hanford Reservation in Richland, WA.

The PAMELA facility began operation in 1985. The TVF began radioactive operations in 1995. The DWPF and WVDP both began radioactive operations in 1996. The Hanford WTP is in the planning, design, and construction stage.

The noble metals are defined as silver, gold, platinum and the platinum group metals: ruthenium, rhodium, palladium, osmium, and iridium. They are called *noble* because of their resistance to oxidation in contrast to base metals that oxidize when heated in air. They are easily reduced and all occur naturally in their elemental form. Of these, however, only ruthenium, rhodium, and palladium are present as fission products in high-level waste. (*Note:* The silver in the SRS defense waste is mostly from silver coated saddles used in iodine strippers). The noble metals are of concern because the metals and oxides (especially RuO₂) are dense and electrically conductive. Almost all of the major production and research vitrification facilities have experienced operational problems that can be traced to the presence of noble metals in the melter. These metals and their alloys and compounds have tended to settle to the floor of Joule-heated ceramic melters. An accumulation of these dense, conductive and highly viscous materials can adversely affect the melter operation by decreasing the power release in the bulk glass in the melter. This can decrease the feed throughput capacity and diminish the melter's ability to maintain the desired operating temperature. This conductive layer can also cause non-uniform and uncontrollable current distributions at the surface of the electrodes that can lead to physical damage or failure of the electrodes.

The high level nuclear wastes of the United States are quite different from those of other countries. The nuclear wastes that the U. S. is (or will be) vitrifying are mainly those resulting from the production of nuclear materials for defense purposes. The high-level wastes in other countries (Germany, Japan, *etc.*) are byproducts from the reprocessing of commercial nuclear fuel. Because of the differences in the waste origins, the expected levels of noble metals in the wastes are also varied. Table 2-1 shows a comparison of noble metals concentrations for selected German, Japanese, and American wastes. As one can see in this Table, the noble metal content of the commercial waste (the Japanese TVF and the German WAK) is considerably higher than that of the defense wastes (SRS HM and Blend, and the

Hanford NCAW). However, the flat-bottomed German PAMELA melter experienced major operational problems while processing the LEWC material. The LEWC has a noble metal content that is very similar to that of the SRS HM and the Hanford NCAW.

Table 2-1. Noble Metals in German, Japanese, and American Waste Glasses*

Component	German PAMELA LEWC/WAK	Japanese TVF GLASS	River	Hanford NCAW'91	
Ru	1000/5100	5530	830/350	870	
Pd	?/3000	2960	310/160	300	
Rh	?/1400	1290	150/68	240	
Ag	trace	93	20/77	320	
Total	?/9500	9873	1310/655	1730	

^{*} Values in ppm elemental projected in the glass product

Considerable testing has been done in support of the U. S. vitrification efforts. Much research has been done at the Savannah River Technology Center (SRTC), Pacific Northwest National Laboratory (PNNL), and the West Valley Demonstration Project (WVDP). PNNL conducted parametric studies in their Research Scale Melter (RSM) in Richland, WA (Cooper, et al., 1994) and sponsored testing in the Engineering Scale Melter (ESM) at the *Institute für Nuklear Entsorgungstechnik at Kernforshungzentrum Karlsruhe* (INE/KfK) in Karlsruhe, Germany (Grunewald et al., 1993a, 1993b). SRTC ran several small-scale melter tests before operating the Integrated DWPF Melter System (IDMS) from 1988 – 1995.

The Integrated DWPF Melter System (IDMS) was designed and constructed to provide an engineering-scale representation of the DWPF melter and its associated feed preparation and off-gas treatment systems. The facility, which operated from 1988 to 1995, was the first engineering-scale melter system capable of processing mercury and flowsheet levels of halides and sulfates (Smith *et al.*, 1989).

In order to characterize the behavior of noble metals, 16 runs, using four types of waste simulants, were conducted in the IDMS facility. These tests were: (1) three runs using a Blend (BL) sludge (a mix of HM and PUREX sludges), (2) four runs using an HM (high noble metals, high aluminum, high viscosity) sludge, (3) seven runs using a PUREX (high iron, low viscosity) sludge, and (4) two runs using the Hanford NCAW sludge (Hutson *et al*, 1990, 1991a, 1991b, 1991c, 1992; Hutson, 1993a, 1993b)

Throughout the operation, samples were taken from the melter floor. With increasing amounts of noble metals fed to the melter, there was a corresponding increase in the amount of noble metals, noble metal compounds, and spinels found on the melter floor. Samples that were taken at the center of the melter and at the outside of the floor diameter (at the face of one of the electrodes) suggested the accumulation of a non-uniform layer of noble metals and crystalline

material. Analysis of these samples revealed a higher concentration of RuO₂ in samples taken from the outer edges of the melt pool than those taken at the center of the melter floor. This suggests that convective currents in the melter tend to move the RuO₂ from the center of the melter (where it enters) to the outside edges. Material balances of these components showed a tendency for the noble metals to be retained as Ru>Rh>>Pd and Ag. It is estimated that the overall percent accumulations in the IDMS for the noble metals during these runs was 35% for Ru, 21% for Rh, and close to zero percent for Pd and Ag.

Noble metal settling was particularly obvious during melter idling (*i.e.*, during those periods when the melter was not feeding or pouring and there was no cold cap). The characteristic settling time seemed to be reached between 10 and 20 days of idle time. Approximately 70% of the Ru in the melter at the start of an idling period settled during this critical time.

As more noble metals were fed to the IDMS melter the upper-to-lower resistance ratio increased, and therefore current requirement for the bottom electrode pair to maintain the desired melt pool temperature increased as well. Initially a current of 450 amps was necessary to maintain a lower glass pool temperature of 1125°C. At the end of the melter testing, 650 amps were required to maintain a temperature of 1070°C. However, the melter did continue to operate with acceptable performance. There was no decrease in the production capacity of the IDMS melter during the tests. A subsequent inspection of the IDMS melter showed that the bottom electrodes had sustained appreciable damage on their lower portions. This damage was probably due to high current densities caused by conductive noble metal deposits that led to preferential firing from the bottom of the electrode faces. Masses of high viscosity material (mixtures of glass, spinels and noble metals) were found at the bottom of the melter.

The ratio of upper-to-lower glass pool resistance proved to be an effective measure in indicating the accumulation of noble metals on the floor of the IDMS melter. This ratio continued to rise during the noble metals runs, thereby showing that the bottom electrode circuit resistance was being lowered. This implied that conductive material (noble metals) was forming on the melter bottom. The post shutdown inspection of the melter showed this was indeed the case.

The West Valley Demonstration melter was designed to be less susceptible to noble metals than the DWPF (which was designed in 1983). The WVDP modifications appear to have been partially successful, yet two-thirds of the electrical resistance in the WVDP melter circuits were lost after one year of operation with noble metals concentrations comparable to SRS HM waste. WVDP is actively following the electrical response of its melter.

There are other reports that provide extensive summary of the results of various noble metal test programs (and operational experiences). Two reports (Smith and Bickford, 1997; Sundaram and Perez, 2000) are particularly thorough and more extensive than this report is intended to be. Readers of this document are strongly encouraged to consult those works for further background.

3.0 Noble Metals Testing in the Integrated DWPF Melter System (IDMS)

3.1 IDMS and DWPF Melters

The DWPF melter is a refractory-lined, sealed, stainless steel vessel with a 6-ft internal diameter and an approximately 7-ft internal height. The 1.5-in thick vessel shell is made of SA 240-304L steel with an OD of 8'-4.5" and an ID of 8'-1.5". All shell components have a minimum two-year design life. The outer shell is water-cooled to maintain the outer vessel at or below 50°C. Primary glass containment is achieved by use of 12-inch thick MonofraxTM K-3 fused cast refractory brick (product of Carborundum Co.).

During operation, the glass is maintained in a molten condition (1050 - 1170°C) by passing a current from the electrodes through the resistive glass pool. Electrical energy is converted to heat inside the molten glass as described by Joule's Law:

$$P = I^2R (Eqn 3-1)$$

where P is the heat produced in the glass

I is the electrical current supplied by opposing electrodes, and

R is the resistance of the glass

The DWPF melter electrodes are four uncooled plates fabricated from InconelTM 690 of sufficient thickness to last greater than two years. The corrosion rate of the InconelTM 690 in the glass pool is expected to be less than 1.8 mils/day. The electrode stems are water-cooled.

The DWPF melter vessel shell is penetrated in the vapor space by four pairs of horizontal resistance-type InconelTM 690 lid heater rods that are maintained at a temperature that assures adequate combustion of the organics in the vapor space. The lid heaters also provide additional heat to the glass pool to increase the melt rate.

The IDMS Melter shell is basically the same as that of the DWPF Scale Glass Melter (SGM, approximately 2/3rd that of the DWPF melter shell). An additional 12 inches of MonofraxTM K-3 was added to the lower interior walls of the melt tank in order to reduce its diameter. The melt pool surface area of the IDMS melter is approximately 1/9th that of the DWPF Melter. Melt rate is directly proportional to the surface area. Therefore, the IDMS Melter could be slurry-fed to produce glass at 25 lb/hr (the DWPF design production rate is 228 lb/hr). Table 3-1 gives a comparison of the two melters.

Two horizontally-entering InconelTM 690 lid heaters provided an additional 60 kW of heat to vaporize water from the slurry feed, melt and the glass, and combust organics in the feed. The lid heaters were maintained at 950°C by passing current through the tubes.

DWPF Melter **Parameter IDMS Melter** $3 \text{ ft2} (0.29 \text{ m}^2)$ $28 \text{ ft}^2 (2.61 \text{ m}^2)$ Melt surface area 18 ft3 (0.20 m³) 87.6 ft3 (2.48 m³) Melt volume 27 in (69 cm) Centerline depth 37 in (95 cm) Glass content (max) 1063 lbs (482 kg) 13,136 lbs (5956 kg) 228 lb/hr (103 kg/hr) Production rate 25 lb/hr (11 kg/hr) 8 lb/hr/ft² 8 lb/hr/ft² Melt rate Residence time 44 hrs 58 hrs

Table 3-1. IDMS/DWPF Melter Comparison

Glass pouring from the IDMS melter was initiated by creating a vacuum at the canister relative to the melter vapor space. A flexible set of stainless steel bellows provided a vacuum seal between the melter and the canister during pouring. These cylindrical canisters were 31-in tall with a 10-in diameter. Although the slurry was fed continuously to the melter, glass was poured in batches. Additional information about the IDMS facility can be found in the start-up report (Smith *et al.*, 1989).

Table 3-2. Characteristics of Melter Electrodes

Characteristic	IDMS Melter	DWPF Melter
Upper pair surface area (ft²)	1	3.7
Lower pair surface area (ft ²)	0.74	3.3
Electrode power (kW)*	20	80
Design current density (amps/in ²)	5	5
Distance between electrodes:		
- across melter (in)	21.2	56
- top and bottom (in)**	6.75	10
- and the floor $(in)^{\dagger}$	2.5	

per pair under normal operation

3.2 Summary of IDMS Noble Metals Runs

The IDMS conducted a total of 16 noble metal (or noble metal related) runs during its operation. They were conducted using four types of simulated wastes (Blend, HM, PUREX, and NCAW) with varying amounts of noble metals. Some of the sludge compositions were modified in order to judge the effects of components such as mercury

^{**} distance between bottom of top set of electrodes and the top of the bottom set of electrodes

distance between the bottom of the bottom electrode and the melter floor immediately below

and nitrite. Specific compositions of each of the sludges can be found in Campaign Summary Reports (Hutson *et al.*, 1991; Zamecnik *et al.*, 1993; Hutson, 1993). A general summary of conditions for each of the IDMS noble metal-containing runs is given in tabular form in Table 3-3. The specified noble metals amounts (in the waste sludge simulant) are given in Table 3-4.

Table 3-3. IDMS Run Summary

						Mercury	NM	Te, Se	Glass Prod
Run ID		Sludge Type	PHA Type	Frit Type	Acid Type	Amounts	Amounts	Amounts	(lbs)
Blend1	BL1	Blend	HAN	FRIT-202	90% Formic	Blend	Blend	Blend	2970
Blend2	BL2	Blend	HAN	FRIT-202	90% Formic	Blend	Blend	Blend	5376
Blend3	BL3	Blend	HAN	FRIT-202	90% Formic	None	None	None	1595
HM1	HM1	HM	HAN	FRIT-202	90% Formic	None	None	None	3156
HM2	HM2	HM	HAN	FRIT-202	90% Formic	None	НМ	НМ	2949
HM3	HM3	HM	HAN	FRIT-202	90% Formic	None	HM	HM	3635
PUREX1	PX1	PUREX	HAN	FRIT-202	90% Formic	None	HM	HM	3344
PUREX2	PX2	PUREX	HAN	FRIT-202	90% Formic	None	HM	HM	4232
PUREAZ	PAZ	PUREA	пан	FK11-202	90% FOIIIIC	None	ПМ	пілі	4232
HWVP1	HV1	NCAW	None	PNNL FY'92	90% Formic	None	NCAW	NCAW	3390
HWVP2	HV2	NCAW	None	PNNL FY'92	90% Formic	None	NCAW	NCAW	4561
HM4	HM4	HM	HAN	FRIT-202	8 M Nitric	HM	HM	HM	3226
PUREX3	PX3	PUREX	HAN	FRIT-202	8 M Nitric	HM	HM	HM	5108
PUREX4	PX4	PUREX	Late Wash	FRIT-202	8 M Nitric	НМ	НМ	НМ	4850
PUREX5	PX5	PUREX	Late Wash	FRIT-202	8 M Nitric	HM	HM	HM	4075
PUREX6	PX6	PUREX	Late Wash	FRIT-202	11 M Nitric	HM	HM	HM	1693
TOREAU	1 740	IUKLA	Luic Wasii	1 K11-202	11 WI WILL	111/1	111/1	11171	1073

Table 3-4. Sludge Noble Metal etc. Concentrations

	Blend	HM	PUREX	NCAW
Element	wt-%	wt-%	wt-%	wt-%
Ru	0.1	0.217	0.028	0.231
Rh	0.018	0.038	0.008	0.064
Pd	0.045	0.079	0.026	0.08
Ag	0.014	0.014	0.014	0.084
Hg	1.588	3.263	0.102	0
Te	0.022	0.048	0.006	0.06
Se	0.002	0.004	0.001	0.009

(wt-% of the sludge soluble and insoluble solids)

3.3 Behavior of the Noble Metals

The rate of accumulation of the noble metals in the melter is a function of the size, distribution, and chemical forms of the noble metals and/or the noble metal compounds in the glass. Samples were taken from various points in the melter system in order to understand how the different processing steps affect these parameters. Each of these samples was examined by a variety of analytical methods.

In each of the runs, the noble metal compounds were added to the alkaline waste sludge simulant in the chemical processing vessel (the SRAT/SME). The palladium, rhodium, and silver were added as nitrate solutions. The ruthenium was purchased as RuCl₃ and was subsequently converted (except for PX6 when it was added as RuCl₃) to a nitrosylruthenium hydroxide (RuNO(OH)0₃) slurry, the anticipated form of the ruthenium in the SRS waste.

Feed slurry samples were taken during periods of continuous melter feeding. These samples were then dried, washed with distilled water, and centrifuged. The resulting insoluble solids were examined by Scanning Electron Microscopy/Energy Dispersive Analytical X-Ray (SEM/EDAX). These analyses revealed scattered palladium "nuggets" of about 1 μ m and, in melter feeds containing mercury, amalgams of Hg/Ag and Hg/Ag/Pd. No individual or amalgamated Ru or Rh particles were observed in any of the melter feed slurry solids. In general, the noble metals were present in the melter feed slurry as either very small, finely dispersed particles or as soluble salts.

During continuous feeding of the slurry simulant, a "cold cap" region forms on the surface of the molten glass. It is in this area that almost all reduction/oxidation reactions occur and gaseous vitrification products are evolved. Several times during the IDMS operation, after material had been fed to the melter to form a cold cap that sufficiently covered the molten glass, a dip sample of the cold cap region was taken. Analysis of those partially vitrified samples revealed RuO₂ needles of up to 20 µm long present in 20 to 50 µm clusters. The samples also contained scattered 1 µm AgI salts, RuS₂, Pd tellurides and selenides, and complex mixtures of Pd/Ag/Te/I/S/Cu. These cold cap samples also provided some evidence as to how this area physically and chemically influences the agglomeration of these species. The SEM micrographs indicated the noble metal compounds (especially the Pd) were preferentially located on the surface of the solidified foam (gas bubbles). This suggested that the frothing, which takes place as a result of vitrification off-gases may promote the growth of palladium metal nodules. It has also been suggested that palladium oxides may decompose to metallic Pd and oxygen, with the Pd transported to the melt surface within the oxygen bubble. Once at the melt surface the Pd particles may combine with other free particles to form nodules that eventually then settle to the melter floor.

The formation of deposits in the melter off-gas line has been a problem common to many slurry-fed melters. These deposits are normally composed of alkali-rich chlorides, sulfates, borates, and fluorides with entrained Fe₂O₃, spinels, and frit particles. Deposit samples that were obtained from the IDMS melter off-gas line were composed of those familiar components and also contained trace quantities of RuO₂, (Ru,Rh)O₂, and Ru/Rh/Te mixtures and some entrained Cd compounds during the NCAW processing (Hutson, 1993). While the formation of RuO₄, a toxic gas, is

possible in very oxidizing conditions, most of the Ru exiting the melter was the result of entrainment rather than volatility as the RuO₂ in the melter off-gas deposits were most often associated with entrained spinel crystals.

Analysis of the soluble fraction of the melter off-gas condensate revealed very low concentrations of the noble metals. However, analysis of the insoluble solids present in the off-gas condensate showed the solids to contain RuO_2 crystals, spinels, and insoluble silver halide (AgI, AgCl) salts. However, the amount of the noble metals exiting the melter through the off-gas line is small and does not significantly affect the overall mass balance of any of the elements.

The canistered glass products of several IDMS campaigns were examined by SEM/EDAX. Ruthenium was the most frequently observed of the platinum group metals in the glass product. The ruthenium was present as both individual and clustered acicular (needlelike) RuO_2 crystals that were usually $< 10 \, \mu m$.

The RuO₂ was also quite often associated with (Ni,Mn)Fe₂O₄ and (Ni,Mn)Cr₂O₄ spinels. It had been previously shown that RuO₂ can serve as a seed for the heterogeneous nucleation of these spinels and other devitrification products (Bickford and Jantzen, 1986). The SEM/EDAX analysis of the IDMS glass also revealed spinel growth which had been nucleated by aggregates of (Ru,Rh)O₂, Ru/Rh, Ru/Pd, and Rh/Pd. Upon further analysis using Transmission Electron Microscopy (TEM), it was found that the Ru and Rh oxides were not only acting as nucleating agents for the spinel formation, but the Ru and Rh were also substituted with other spinel components to become part of the spinel structure itself. Palladium, as Pd and Pd/Te, was also occasionally found in the canistered glass product. The silver is completely dissolved within the glass matrix and was never found as a separate phase.

3.4 Material Balance

Material balances were completed for the noble metals. Several analytical methods were used to measure the noble metals in glass and melter feed slurry. Each analytical method showed a tendency for the noble metals to be retained in the melter in the following relative amounts: Ru > Rh >> Pd > Ag. The estimated amount retained (as the % of that which was fed to the melter) is given in Table 3-5.

Table 3-5. Estimated Retention of the Noble Metals in the IDMS Melter

	Estimated Amount
Component	Retained in Melter
Ru	35.1%
Rh	21.2%
Pd	<1%
Ag	3.5%
Te	10.5%
Se	43.0%

These results suggest that palladium was nearly completely flushed from the melter. However, melter floor samples contradict this. However, except in a few samples, the Pd found on the melter floor was present as very small $(1-\mu m)$ particles and very dispersed. This, along with other analytical measurements, suggested that <10% of the Pd was retained in the melter. As expected, very little, if any, silver was retained in the melter as the silver is readily dissolved in the borosilicate glass and no silver or silver compounds were ever found on the melter floor.

3.5 Effects on the Melter Operation

The electrical characteristics of the IDMS melter were constantly monitored in an effort to judge the effects of the deposition of glass insoluble components. Initially the resistance of the lower melt pool was used as an indication of the accumulation of a conductive layer on the melter floor. However, this measurement is not entirely effective in determining the extent of accumulation of deposits in that each glass composition has a different electrical resistance at a given temperature. Therefore the ratio of the upper melt pool resistance to that of the lower melt pool was monitored as the indication of conductive material on the melter floor. In using this measure, changes in the melt resistivity due to differences in glass temperature or composition were normalized. A rise in this ratio suggested an increase in the amount of conductive material on the melter floor. The resistance of the glass is calculated as follows:

Resistance_{AB} =
$$\frac{\text{Voltage}_{AB}}{\text{Current}_{AB}}$$
 (Eqn 3-2)

and

$$Resistance_{CD} = \frac{Voltage_{CD}}{Current_{CD}}$$
 (Eqn 3-3)

so that

Resistance Ratio =
$$\frac{\text{Resistance}_{AB}}{\text{Resistance}_{CD}}$$
 (Eqn 3-4)

where AB = upper electrode pair and CD = lower electrode pair

During the first 550 days of operation (many of those days were spent idling, *i.e.*, no feeding) the ratio was stable, oscillating from 1.1 to 1.3. The ratio then began to increase dramatically and continued upward to 2.3 - 2.5. The quick increase in the resistance ratio corresponded to a time when melter floor samples revealed a significant increase in the amount of material on the melter floor. A statistical analysis of the effects of noble metals on the IDMS melter upper-to-lower resistance ratio for all the noble metals runs from BL1 to HWVP2 (a total of 17,620 grams of noble metals were added) was done (Smith and Bickford, 1997). The conclusion was that there was a statistically significant

(95% confidence level) increase in this ratio as the noble metals were added the melter. During operation, the resistance of the lower glass pool decreased, thereby increasing the current requirement to the lower electrodes. Eventually a current limit (set at 600 amps) prevented the melter from being operated in the desired temperature range (1100 - 1150°C). The current limit was increased and approximately 650 amps were required to maintain the lower glass pool at 1070°C. That current slightly exceeded the design current density (6.1 amps/in² versus the design value of 5.0 amps/in²).

The IDMS melter was idled for several extended periods (> 20 days). There were several reasons for this (Smith and Bickford, 1997) including the normal outages that one expects to experience in a pilot-scale research facility. The Germans noted that changes in the electrical resistance in the glass pool were especially obvious during extended periods of idling. It is thought that the convection currents present during slurry feeding (driven by the cold slurry layer on the molten pool known as the "cold cap") were sufficient to keep the noble metal particles suspended. The suspended noble metals then exited the melter as inclusions in the glass product. However, during extended idling periods, the convection currents were relatively minor (no cold cap coverage). The noble metals particles then settled more easily in the stagnant molten glass pool. Plots of noble metals in the glass product showed that the concentrations (especially Ru and Rh) decreased significantly during periods of idling. The concentrations then increased, toward the target concentration in a profile similar to that predicted in a Continuously Stirred Tank Reactor (CSTR), when continuous feeding was reinitiated. This indicated that most of the deposition in the IDMS melter took place during extended periods of idling.

The changes in concentration of Ru during periods of idling were examined using data from glass collected from "small pours" during idling periods. This is shown in Figure 3-1. The data followed the same general trend as a hypothetical sedimentation relationship (Smith and Bickford, 1997).

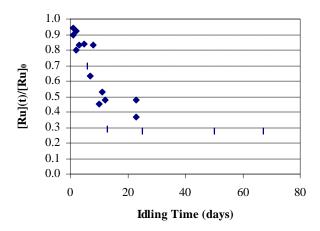


Figure 3-1. Ruthenium Settling during Periods of Idling in the IDMS Melter

Thus one can generalize that initially the relative concentration varied linearly until a critical point is reached, and then the rate of change of concentration decreased rapidly until the ultimate concentration is reached. The data suggested that the Ru was present in the melt as particles of various sizes and shapes, some that settled easily and some that did not. The ultimate concentration represented the Ru that did not easily settle. The data indicated that the critical settling point was reached between 10 and 20 days of idle time. The data taken for idle times less than 20 days was used to generate a least-squares relationship for relative Ru concentration versus idle time for the IDMS melter. The linear region was described by:

$$\frac{[Ru](t)}{[Ru]_0} = 0.9814 - 0.04713t$$
 (Eqn 3-5)

In this equation, t is idle time in days, [Ru](t) is the concentration of ruthenium in the melt as a function of time, and $[Ru]_0$ is the initial ruthenium concentration in the melt (at t=0).

The ultimate relative concentration appeared to be between 0.25 and 0.30, indicating that approximately 25 to 30% of the Ru in the melter was of a size or shape that did not settle easily.

3.6 IDMS Melter Shutdown/Inspection

The IDMS melter was shutdown on June 30, 1995 after operating continuously since October 1988. During deinventory of the melter, glass samples were collected from the floor and drain of the IDMS melter in an attempt to determine the composition of any species (spinels and/or noble metals) that may have crystallized and settled during the 7-year operation. An inspection of the melter refractory, melter components, and off-gas piping was also completed.

A high vacuum pour was initiated to remove as much glass from the melter as possible since it was expected that bottom draining would not be effective. Approximately twelve inches of glass remained after the completion of the high vacuum pour. An attempt was made to drain the melter through the drain valve. Repeated attempts were unsuccessful in draining any glass through the drain valve primarily because the drain valve Zone 1 heater was inoperative. The top head melter components (feed tube, level probe, thermowells) were removed from the melter. The melter power was shutdown and the melter cooled to room temperature.

After cooling, the remaining glass (approximately 12 inches) in the bottom of the melter was core-drilled and bead blasted for cleaning (analysis of these core samples is discussed in a later section). An inspection of the melter refractory, melter components, and off-gas piping, as well as sampling of the material at the bottom of the melter was done. Aggressive attack of the K-3 refractory occurred at the bottom of the melter drain. The InconelTM 690 drain valve and pipe had extensive corrosion. The InconelTM 690 upper electrode was in excellent condition above the normal glass level while the bottom of the electrode exhibited some wear. The InconelTM 690 lower electrode, continuously in contact with the melt, had lost about 12% of the material from the face of the electrode.

Approximately two inches of material was lost from the bottom face of the lower electrodes, and the electrodes were very rounded in this area. Mechanisms considered for this are all associated with noble metals deposits; 1) low viscosity glass at a hot spot near the junction of the electrodes and the glass could have accelerated wear, 2) high electrical current densities could have accelerated oxidation and electrochemical attack of the electrodes, 3) alloying of the electrodes at the surface with the noble metals, Se or Te could have adversely affected the ability of the InconelTM to develop a passive corrosion inhibiting surface layer, and 4) localized overheating could have caused localized electrode melting.

The faces of the upper electrodes were also heavily worn, especially at the ends. The extent of the attack was proportionally higher in this melter than in other SRTC melters that had operated for comparable times. The electrodes were still functional.

The most likely cause of the high attack at the bottom of the electrodes is a combination of mechanisms 1 and 2. The general wear pattern is consistent with attack in regions of high current density, which adversely affects electrochemical corrosion rates. High current densities can also be expected to produce local high temperature regions, especially in normally stagnant areas such as under the bottom electrodes. There was no direct indication of electrode melting which has been seen in smaller melters and which generally produces a melter short.

Noble metal alloying and enhanced corrosion is unlikely to have been an effect since the thermowell was examined in detail and this mechanism was not observed. However, it is possible that the combination of noble metals and the electrical currents at the electrode faces resulted in such an effect. Detailed metallurgical examination of the electrode would be necessary to determine the actual mechanism.

4.0 Melter Core Samples and Floor Deposits

4.1 Floor Samples Taken During Operation

After introduction of noble metals in the IDMS melter, samples of the melter floor were routinely taken. The samples were taken using a "grain thief" type of sampling device. The samples were normally taken through the feed tube port (center of the melt pool), but were also taken at times at the borescope port (near the face of one of the electrodes near the sidewall).

About 2 months after feeding the initial noble metal-doped slurry, a sample was taken of the melter floor (actually at about 1 - 2 inches above the floor). The sample revealed no evidence of the presence of any noble metals or crystalline material. Another sample of the melter floor (again at about 1-2 inches) was taken approximately 5 months after the initial floor sample. That sample showed very scattered RuO₂ needles approximately 5 - 15 μ m in length. The needles were present, for the most part, in 20 - 40 μ m clusters. There was no evidence of any deposition of Pd, Rh, Ag, Se, Te or any of their compounds.

Approximately 13 months after the introduction of the noble metals, a third melter floor sample was taken. The sampler was modified to allow samples to be taken within 1/2-in of the melter floor. The sample revealed a significant increase in the amount of RuO₂, compared to that of the earlier samples. There was also evidence of a small amount of Pd deposition. The sample was, however, relatively free of spinel accumulation.

Since there was a considerable increase in the amount of deposited RuO₂, the frequency of melter floor sampling was increased and another sample was taken at 15 months into noble metal operations. This sample was taken just before the start of the feeding of the first batch of NCAW (Hanford) feed slurry. SEM micrographs of that sample revealed a dense layer of melt insolubles, mainly RuO₂ and (Ni,Mn)(Fe,Cr) spinels. That sample also revealed the first evidence of Rh deposition on the melter floor. During the sampling, it was noted that there was an obvious layer on the melter floor that was much more viscous than the bulk glass. This viscous layer (estimated at approximately 1-2 inches) was noted with all subsequent samplings.

Another sample was taken at 16.5 months into processing, during the feeding of the HWVP1 melter feed slurry. That sample again revealed significant RuO_2 and spinel accumulation and individual metallic Pd. After the completion of the feeding of the HWVP1 melter feed, a sample was taken of the melter floor (17 months). That sample revealed dense RuO_2 and spinel accumulation and scattered Rh.

A melter floor sample was taken after completion of the feeding of the HWVP2 slurry (19 months). The sample was chemically analyzed but not examined by the microscope. The chemical analysis indicated that the Ru, Rh, and spinel components (Cr, Mn, and Fe) had all decreased, suggesting that the noble metals and spinels had been "flushed" from the melter or possibly rearranged on the melter floor. Plots of the components in the glass produced during the HWVP

operations showed an abrupt increase in Ni and Cr (spinel components) between HWVP1 and HWVP2. This, along with SEM examination and chemical analysis of melter floor samples (taken at the center) gave further support to the notion that the spinels were moved from the melter center to the outer edge and flushed out with the glass. However, although the RuO₂ seemed to also be moved from the center to the outside edge, it was not flushed. The concentration of Ru in the glass product decreased with the idling time between HWVP1 and HWVP2, thereby indicating settling of RuO₂ from the bulk melt and an increase in the concentration of RuO₂ on the melter floor. This apparent spinel flushing is not possibly advantageous with respect to increasing the lifetime of the melter. Since the spinels are not highly conductive compared to the noble metal compounds, they may behave as insulators and increase the overall resistance of the deposited material.

Another sample was taken at 19.5 months into noble metals operations. The sample was the first taken through the borescope port. The sampling point was just at the face of the bottom electrode closest to the riser throat entrance. The SEM examination revealed that there was much less accumulation of spinels than in previous samples. Chemical analysis confirmed that the spinel components (Cr, Fe, *etc.*) were lower than previous samples. However, the concentration of ruthenium was much higher (9 wt-%) than in previous samples. This further supported the notion that the spinels had been flushed out while the RuO_2 was merely swept from the center of the melter to the outside of the melter floor. SEM micrographs also revealed the normal RuO_2 clusters, Rh-nucleated Cr/Ni/Fe spinel, and an elongated formation of ruthenium disulfide, RuS_2 . The presence of RuS_2 in this sample was surprising since this compound decomposes at temperatures > 1000° C. This suggests that the temperatures at the outside portion of the melter may have been $<1000^{\circ}$ C despite the fact that the bulk glass temperature was held at $1100 - 1150^{\circ}$ C.

Another floor sample was then taken from the center of the melter (feed tube port) at 20 months. That sample revealed large amounts of deposited material, mainly RuO_2 and spinels. The next sample was taken from the borescope port after 21 months. The sample showed a dense accumulation of noble metals and spinels and again confirmed the presence of RuS_2 . The analysis of this sample confirmed an increase in spinel components (especially Cr).

Table 4-1 (feed tube port) and Table 4-2 show the amounts (in wt-%) of selected components in each melter floor sample. These results suggest the progressive formation of a non-uniform layer of noble metals (mainly RuO₂) and Ni/Fe/Cr spinels on the melter floor. The analyses of the samples that were taken at the borescope port tended to have a higher concentration of Ru as compared to the samples taken from center of the melter (feed tube port).

Table 4-1. Analysis of IDMS Melter Floor Samples Taken during Operation from the Feed Tube Port (the center of the melt pool)

Sample	Sample	Ag	Cr	Fe	Mn	Ni	Pd	Rh	Ru	Zr
ID	Date	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%
I-3701	2/25/91		0.10	8.14	1.65	0.63			< 0.01	0.04
I-4313	8/23/91	0.01					0.03	0.01	0.02	
I-4790	10/15/91	< 0.01	0.82	8.89	2.45	1.81	0.07	0.41	4.68	0.04
H-0330	12/4/91	< 0.01	3.19	11.08	2.52	1.21	0.02	0.03	0.42	0.63
H-0329	12/18/91	0.02	3.40	9.01	1.23	1.07	< 0.01	0.30	6.20	1.39
I-4804	2/18/92	0.03	0.51	4.35	0.43	0.61	1.01	0.93	7.33	2.02
I-5242	3/27/92			4.39					5.53	
I-6670	10/29/92	0.03	0.25	6.40	1.18	0.84	0.33	0.46	4.73	0.59
I-8228A	9/28/94	< 0.018	0.50	5.99	0.86	1.01	< 0.136	0.37	4.22	0.50
I-8228B	9/28/94	< 0.021	0.46	4.67	1.14	1.33	< 0.155	1.41	15.60	0.64

Table 4-2. Analysis of IDMS Melter Floor Samples Taken during Operation from the Borescope Port (at the face of the electrode near the riser throat)

Sample	Sample	Ag	Cr	Fe	Mn	Ni	Pd	Rh	Ru	Zr
ID	Date	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%
I-5219	3/6/92	0.03	0.49	4.78	0.46	0.47	0.08	0.27	9.59	2.11
I-5270	4/20/92	< 0.01	1.94	4.52	0.75	1.16	< 0.01	0.14	11.40	1.00
I-6823	7/22/93	< 0.01	0.24	6.37	1.12	0.81	< 0.01	0.59	8.85	0.51
I-8227	9/28/94	< 0.018	1.08	6.38	1.13	1.31	< 0.138	0.58	5.65	0.63

The accumulation of RuO₂ and Rh/Pd/Te is consistent with that observed in waste vitrification simulations in Germany (Krause and Luckscheiter, 1991). However, in melter floor samples taken from a research melter in Karlsruhe, Germany, the RuO₂ needles were much more acicular and perfectly formed. The RuO₂ crystalline growth in SRS, Hanford, and West Valley glasses and cold cap samples appeared to be inhibited by the glass itself. This may be explained by the fact that glass beads are used as the primary glass forming additive in German tests while tests conducted in the IDMS facility and the West Valley SFCM used a finely ground glass frit and batch chemicals. The "large" voids present between the glass beads of the German slurry feed allowed unhindered growth of the RuO₂ crystals in the cold cap. The frits used in U. S. melters soften at lower temperatures than the German glass beads and eliminate the voids in the cold cap thus hindering the growth of the RuO₂ crystals.

4.2 Post Shutdown Floor Melter Samples

After the melter was de-inventoried as much as possible, it was allowed to cool and the remaining glass (approximately 12 inches) in the bottom of the melter was core-drilled. A total of 38 core samples were obtained radially between 0 - 6 inches of the bottom drain, between 6 - 12 inches, and >12 inches from the centrally located drain on the melter floor. These samples were analyzed at the Savannah River Technology Center (SRTC) for the following:

- glass and deposit composition
- noble metal concentration
- x-ray diffraction identification of crystalline species
- quantitative analysis of the wt-% spinels in the glass
- redox ratio (Fe⁺²/Fe_{total})

Three samples were taken from each core drill of the 12" of glassy deposits on the melter floor. Replicate #1 was furthest from the refractory and Replicate #3 was closest to the refractory floor. All of the glass/deposit compositions summed to 100 ± 5 wt-% indicating that the samples had been completely analyzed. Only slight enrichment in Cr_2O_3 (~0.5 wt-%) was noticed over the flowsheet amounts run during the lifetime of the IDMS.

All of the melter core samples were analyzed chemically for noble metal content and by quantitative x-ray diffraction for spinel content. The results indicate that the concentration of noble metals and spinels was fairly uniform in the melter core samples taken from the 12" of glass remaining in the IDMS melter. The range of Ru was between 0.022-0.041wt-%, the range of Rh was between 0.007 - 0.012 wt-%, and the range of Pd was between 0.016 - 0.026 wt-%. Analysis by x-ray diffraction (XRD) confirmed that the Ru was present as RuO₂. The wt-% spinel, nominally NiFe₂O₄, was between 3.2 - 8.5 wt-%.

A sodium magnesium chromium silicate (krinovite) was found in every x-ray diffraction spectra as well. No quantitative weight percent analysis was made of this specie, as quantitative x-ray diffraction calibration curves were not available. Krinovite is a known decomposition product of K-3 refractory (Jantzen and Lambert, 1997).

Bead blasting (similar to sand blasting but using larger-size particles that are capable of chipping away at the glass without damaging the melter refractory) and mechanical chipping were used to remove the remaining glass from the melter. No samples were taken since the melter floor glass/deposit material would have been contaminated with the bead material. After the bead blasting was complete, there were still some "blobs" of glassy/deposit material that were attached to the refractory. These blobs were easily removed from the refractory. (*Note:* Unfortunately no record exists to map the location of these samples), and a total of 10 samples were analyzed by the same methods used for the core-drilled samples. Many of the composition analyses summed to less than 100 ± 5 wt-% indicating that the samples had not adequately dissolved during wet chemical analysis. The SRTC sample preparation analyst noted the presence of undissolved residues after sample preparation/dissolution. This is because many spinel compositions are refractory and are very difficult to dissolve with the dissolution techniques used for glass analysis.

Selected components of the floor deposits are given in Table 4-3. Even though the dissolution was incomplete it was obvious from the analyses that these deposits are highly enriched in Cr₂O₃, Fe₂O₃, and ZrO₂ over the amounts of these materials run during the lifetime of the IDMS. The embedded deposits were also somewhat enriched in MgO. The high ZrO₂ content is likely accumulation from the high ZrO₂ Hanford glass that was run in the IDMS HWVP campaigns. However, the NiO content of the melter floor samples was surprisingly low; it was actually comparable to the average concentrations of Ni in melter feed over the IDMS operation (Jantzen and Lambert, 1997). The embedded deposits were also more reduced than the bulk glass. The melter floor samples (BLOBS) had an average Fe⁺²/Fe_{total} of 0.135 as compared to 0.065 for the melter core samples.

All of the embedded samples were analyzed for noble metal content and analyzed by quantitative x-ray diffraction. The results given in Table 4-3 indicate that the concentration of spinels ranged from 27 - 66 wt-%. The range of Ru was also highly enriched and varied between 0.16 - 7.74 wt-%. The range of Rh was between 0.026 - 1.21 wt-%, the range of Pdwas between 0.031 - 0.17 wt-%. Again, X-ray diffraction analysis confirmed that the Ru was present as RuO₂. A sodium magnesium chromium silicate (NaMg₂CrSi₃O₁₀) and a Cr-rich spinel (possibly containing Mg and Al) phase were also found in every x-ray diffraction spectra.

Table 4-3. Wt-% Concentration of Spinel and Noble Metals (Ru, Rh, and Pd) from IDMS Floor Samples

Sample ID	Spinel	Ru	Rh	Pd	Fe	Ni	Cr	Fe ²⁺ /
	Wt-%	Wt-%	Wt-%	Wt-%	Wt-%	Wt-%	Wt-%	$\mathbf{Fe}_{\mathbf{total}}$
Core Max	8.5	0.041	0.012	0.026	-	-	-	-
Core Min	3.2	0.022	0.007	0.016	-	-	-	-
Core Avg	-	-	-	-	7.86	1.31	0.75	0.065
BLOB-1	42	0.330	0.078	0.068	19.74	0.45	14.09	0.142
BLOB-2	66	1.120	0.026	0.062	15.96	0.80	14.53	-
BLOB-3	33	5.370	0.069	0.041	13.54	0.99	10.10	0.034
BLOB-4	29	7.740	1.210	0.066	12.82	0.73	7.78	0.019
BLOB-5	27	5.660	1.000	0.160	13.08	0.32	11.51	-
BLOB-6	51	1.190	0.210	0.083	14.52	0.33	17.51	-
BLOB-7	48	0.160	0.062	0.075	12.95	0.42	17.93	0.111
BLOB-8	27	0.410	0.130	0.031	12.72	1.01	7.74	0.093
BLOB-9	36	1.600	0.390	0.140	15.68	0.57	11.88	0.166
BLOB-10	44	1.700	0.410	0.170	16.55	0.64	12.85	0.193

4.3 Electrical Conductivity Measurements

Several samples from the IDMS were sent to the Pacific Northwest National Laboratory for physical characterization. Samples taken during operation (see section 4.1) and samples taken after the shutdown and inspection (the "BLOB" samples described above) were sent to PNNL for SEM and optical microscopy and for measurement of high temperature conductivity. An example micrograph of BLOB-10 is shown in Figure 4-1.

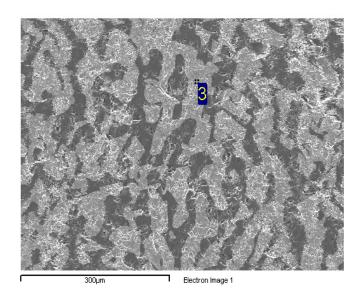


Figure 4-1. SEM Micrograph of IDMS Melter Floor Sample (BLOB-10). (This micrograph shows dense accumulation of Ni, Cr, Fe spinel crystals.)

Approximately 200-g of material was needed for the conductivity measurement. The quantities of the IDMS core and operational samples were insufficient for this measurement. Only the BLOB samples were of sufficient quantity. However, because of the high spinel content of the BLOB samples (see Table 4-3), many would not melt at the measurement temperature (950 – 1350 °C). Table 4-4 gives a summary of the temperature at which the various samples began to melt (or not). The conductivity measurements could only be made using samples BLOB-3, BLOB-4, BLOB-5, and BLOB-8.

Table 4-4. Melting temperatures for IDMS melter floor samples

Sample ID	Began To Melt (°C)		
BLOB-1	Did Not Melt		
BLOB-2	Insufficient Sample		
BLOB-3	1000		
BLOB-4	800		
BLOB-5	800		
BLOB-6	Insufficient Sample		
BLOB-7	Did Not Melt		
BLOB-8	1000		
BLOB-9	1100		
BLOB-10	Did Not Melt		

The results of the conductivity measurements are given in Table 4-5. The DWPF Start-up Frit (Black Frit-165) was also measured as a reference. The results are also shown as plots in Figures 4-2 and 4-3. These figures show that the melter floor (BLOB) material may be considerably more electrically conductive than the bulk glass at the operating temperature of 1150 °C. The sample with the highest noble metal content (BLOB-4, [Ru] = 7.74 wt-%, [NM] = 9.02 wt-%) had a conductivity more than seven times that of the DWPF start-up frit. Figure 4-4 shows the relationship between the resistance (ohms) at 1150 °C and the total noble metal content of the melter floor sample. There is a considerable drop in the resistance with an increase of noble metal content. Figure 4-5 shows the relationship between the conductivity (S/m) at 1150 °C and the total noble metal content of the melter floor sample. The variation in the noble metal and spinel content of these samples (and the resulting conductivity) shows, again, that the floor deposits are non-uniform and non-continuous.

Table 4-5. Conductivity / Resistance of IDMS melter floor samples

Temperature	Temperature	Temperature	Resistance	Resistance	Conductivity
(°C)	(K)	1/T(K)*10000	(ohms)	Corrected*	(S/m)
DWPF Start-up Frit					
1345	1618	6.18	0.76	0.67	50.12
1248	1521	6.57	1.00	0.92	36.69
1148	1421	7.04	1.46	1.37	24.53
1048	1321	7.57	2.24	2.16	15.58
947	1220	8.20	3.92	3.84	8.76
IDMS BLOB-3					
1347	1620	6.17	0.36	0.27	122.33
1249	1522	6.57	0.51	0.42	80.00
1150	1423	7.03	0.73	0.64	52.36
1048	1321	7.57	1.18	1.10	30.66
951	1224	8.17	2.02	1.94	17.35
IDMS BLOB-4					
1345	1618	6.18	0.16	0.07	462.39
1245	1518	6.59	0.19	0.10	325.16
1145	1418	7.05	0.26	0.18	188.76
1044	1317	7.59	0.51	0.43	78.38
945	1218	8.21	1.19	1.11	30.38
IDMS BLOB-5					
1346	1619	6.18	0.29	0.20	171.14
1248	1521	6.57	0.32	0.23	146.72
1149	1422	7.03	0.41	0.32	105.00
1049	1322	7.56	0.60	0.51	65.54
948	1221	8.19	1.17	1.09	30.79
IDMS BLOB-8					
1346	1619	6.18	0.55	0.46	72.62
1248	1521	6.57	0.89	0.80	41.98
1148	1421	7.04	1.30	1.22	27.60
1049	1322	7.57	2.05	1.96	17.12
948	1221	8.19	3.62	3.53	9.51

* The resistances were corrected by subtracting the internal resistance of the electrical conductivity probe from the total resistance measured.

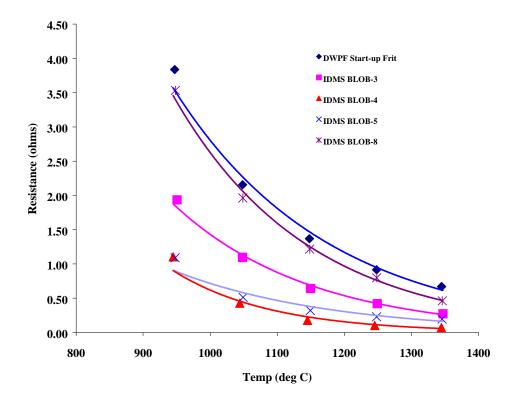


Figure 4-2. Resistance (ohms) versus Temperature (°C) for IDMS melter floor samples (with DWPF Start-up Frit shown as a reference point)

The data were fit to an exponential equation (Eqn 4-1) relating resistance (Ω , ohms) of the glassy material to temperature (T, °C). The fitting parameters for each material is given in Table 4-6.

$$\Omega \text{ (ohms)} = Ae^{BT(^{\circ}C)}$$
 (Eqn 4-1)

Table 4-6. Fitting parameters for relationship between Resistance and Temperature

Material	A	В	\mathbb{R}^2
DWPF Start-up Frit	221.19	-0.0044	0.9888
IDMS Blob #3	191.68	-0.0049	0.9950
IDMS Blob #4	589.93	-0.0069	0.9655
IDMS Blob #5	51.059	-0.0043	0.9363
IDMS Blob #8	383.71	-0.0050	0.9971

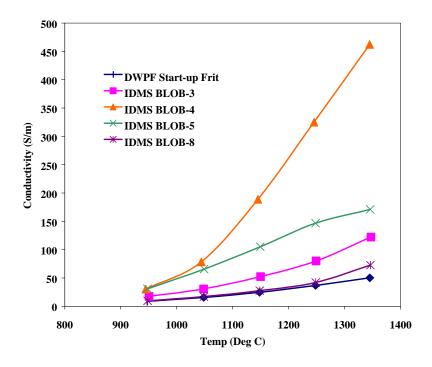


Figure 4-3. Conductivity (S/m) versus Temperature (°C) for IDMS melter floor samples (with DWPF Start-up Frit shown as a reference point)

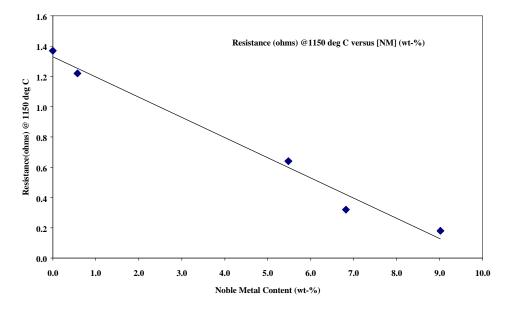


Figure 4-4. Relationship between Noble Metal Content ([NM], wt-%) and the Measured Resistance (ohms) at 1150 °C for IDMS Melter Floor (BLOB) Samples

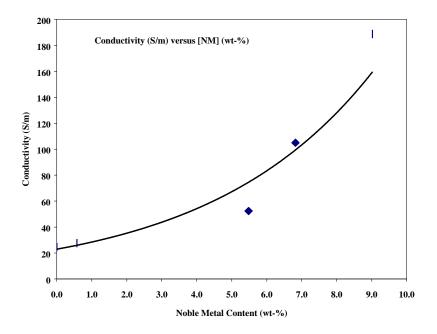


Figure 4-5. Relationship between Noble Metal Content ([NM], wt-%) and the Measured Conductivity (S/m) at 1150 °C for IDMS Melter Floor (BLOB) Samples

5.0 Noble Metals Testing in the PNNL Engineering Scale Melter (ESM)

The Engineering Scale Melter (ESM) is a $1/10^{th}$ -scale DWPF type melter (*Note*: The Hanford Waste Vitrification Plant, HWVP, was being designed to use the DWPF melter). The ESM was constructed and operated by personnel at the *Institute für Nuklear Entsorgungstechnik at Kernforshungzentrum Karlsruhe* (INE/KfK) in Karlsruhe, Germany (Grunewald *et al.*, 1993a, 1993b) under a contract with PNNL. The ESM testing was conducted in the summer of 1992 to evaluate noble metals behavior during melter operation at the projected levels of the proposed Hanford vitrification plant. The overall objective of the ESM test was to operate the melter under anticipated HWVP process conditions over sufficient run time to determine if the noble metals accumulate in the melter as a function of time and feeding conditions. The ESM operated for 9 days without noble metals for shakedown testing and for 49 days with noble metals. The final mass balance concluded that 35 wt-% of the ruthenium, rhodium and palladium fed to the melter settled to the melter floor. Samples taken from the bottom of the melter at the end of the run had high concentrations of noble metals, some 20 to 45 times higher than those of the nominal glass. Near the end of the run, the electrical resistance between the lower set of electrodes decreased by 10-15 %, further indicating a settled layer of noble metals (Sundaram and Perez, 2000). It can be presumed that operation for longer periods would have resulted in further accumulation and eventually melter damage.

The ESM has been moved to the Clemson Environmental Technologies Laboratory (CETL) at Clemson University (Anderson, South Carolina). The melter had already been drained; however, it still contained a thin (<0.5-in) layer of glassy material on the melter floor. This material was sampled on 3/29/01 at the CETL facility. Figure 5-1 shows an overhead schematic of the melter with the sample locations shown as numbers on the schematic.

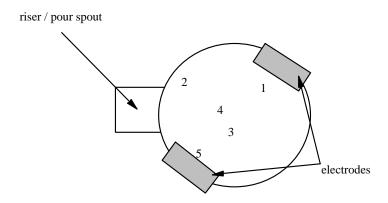


Figure 5-1. Overhead Schematic of the Engineering Scale Melter (ESM). (*Note:* The numbers indicate melter floor sampling locations.)

The samples were shipped, along with some archived IDMS samples (as described earlier), to the Pacific Northwest National Laboratory for characterization. The quantity of the ESM samples was insufficient for measurement of high

temperature conductivity. However, chemical characterization was done (though Ru was the only one of the noble metals measured) and SEM/EDX analysis was also done. The results of the chemical characterization are given in Table 5-1. As with the IDMS floor samples, the ESM samples suggest a non-uniform (Ru varied from 2.20 to 7.44 wt-%) accumulation of noble metals and spinel components (Ni, Cr, Fe, and Zr). The samples were all very high in chromium (see Table 5-1). Although, based on the IDMS results, it seems likely that there is some accumulation of Cr-containing spinels, the primary source of Cr in these samples is likely from the MonofraxTM K-3 refractory. Since the glassy floor material was so thin, it was nearly impossible to remove just that layer with no contamination from the refractory. The samples showed a significant enrichment of Ru as compared to the target NCAW'91 glass composition (Hutson, 1993a). The samples nearest to the electrodes (#1 and #5) had the lowest composition of spinel components (Ni, Fe, Cr, Zr) and the highest composition of Ru. In fact, the Ni values were near that of the NCAW glass target and the Fe values were below the target. The Zr is only slightly enriched in these samples. The sample taken at the outside edge furthest from the electrodes (#2) had the highest concentration of the spinel components and the lowest concentration of Ru (although there was still a significant enrichment over the target Ru concentration). The disparity in the concentration of various components are likely due to a combination of uneven convection currents in the melter and to temperature differences within the melter (cooler regions would tend to be higher in spinel components).

Table 5-1. Selected Components in Floor Samples from the Engineering Scale Melter (ESM)

Sample Location	Ru wt-%	Ni wt-%	Cr wt-%	Fe wt-%	Zr wt-%
1	5.65	0.83	2.55	3.97	4.04
2	2.20	2.70	5.00	6.92	4.86
3	3.96	1.15	2.51	4.14	4.94
4	4.51	1.46	3.56	4.30	4.39
5	7.44	0.55	1.15	3.46	4.11
Target*	0.09	0.52	0.06	5.68	3.19

^{*} Target in NCAW'91 glass (Hutson, 1993a)

6.0 West Valley Demonstration Project Operating Experience

At the West Valley Demonstration Project (WVDP), the slurry-fed ceramic melter (SFCM) was designed prior to the sloped bottom German and Japanese melters. It has a unique prismoidal shape with sloping walls and a bottom electrode that was intended to minimize noble metals effects. The expected ruthenium concentration in WVDP radioactive glass was 0.08% by weight based on fuel burn-up fission product yields. Analyses after start of radioactive operations indicate actual values of 0.06 to 0.15%. The expected concentration is very similar to DWPF glass if made from HM sludge (see Table 2-1).

The SCFM was in test operation from December 1984 to December 1989 to vitrify simulated nuclear waste slurries (Jain *et al.*, 1991). In that study, deposits of melt insolubles and crystallized species that accumulated on the SFCM floor during the vitrification process were analyzed. The results indicated that the thickness of the sludge layer on the floor of the SFCM was not more than 6-cm deep and consisted mostly of Fe-Cr spinels, and RuO₂ dispersed in a glassy borosilicate matrix. Also, crystalline Ce₂O₃ and undissolved phases consisting primarily of alumina and chromia were present in trace amounts but were inhomogeneously distributed in the glassy matrix on the SFCM floor. Greater than 87% of the RuO₂ fed to the melter was flushed out with normal glass pouring.

Five days of non-radioactive surrogate operations with noble metals were conducted on the WVDP melter before radioactive operations were started. No electrical disturbances were noted during the short test period, but deposits were found on the melter bottom and at the dihedral angle between melter walls, analogous to the German W-4 campaign experience. A preliminary material balance showed that 95% of the Ru had been washed out via the overflow drain.

The WVDP began radioactive operations in 1996, and after approximately one year of operation, in the fall of 1997, a dramatic change in the electrical resistance of the melter was noted. This required adjustment to current control limits to the melter. Long term trending of historical data from the WVDP melter indicated a downward trend in the electrical resistance between the melter electrodes and skewing of current toward the bottom electrode. The problem was significant enough that a team of vitrification experts was assembled. Preliminary conclusions from that team were as follows.

- Deposits of noble metals most likely caused the downward trend in electrical resistance and the skewing of current towards the bottom electrode.
- The primary effect caused by the accumulation of noble metals was that more current was required to maintain the same power input into the melter.
- Trending indicated that sufficient current capacity was available to maintain the desired glass production rate in the short term.

The assembled team of vitrification experts gave numerous recommendations for addressing the WVDP noble metals concerns in 1997. The team recommended that WVDP should:

- assess the adequacy of currently available diagnostic/monitoring capabilities for detecting accumulation of noble metals;
- develop enhanced melter monitoring and detection capabilities with appropriate action limits;
- predict future melter power needs and develop "work arounds" to meet these needs;
- continue to collect and evaluate data aimed at characterizing the noble metal deposits in the melter;
- develop tools to dislodge the deposits of noble metals in situ;
- develop methods for flushing and draining the melter to remove deposits; and
- develop methods for visually inspecting the melter if it is drained and mechanically dislodging the deposits.

The response of the West Valley melter to the slow accumulation of noble metals has been successfully modeled using a "corner model". This is described in another report (Sundaram and Perez, 2000). The electrical response of the West Valley melter, after gradually declining, remained fairly constant and operation continued. The tank waste has currently been completely fed and the facility is processing tank residue and heels. A sample of the melter floor material has been taken and complete characterization is in progress. During sampling, it was noted that there was a highly viscous layer > 2" present on the melter floor (Palmer, 2001).

7.0 DWPF Operation

7.1 Operational Experiences to Date

The DWPF melter has been in radioactive operation since 1996. The facility is nearing completion of Tank 51 sludge 1B (macrobatch 2). Some historical data seemed to indicate that the melter is now displaying symptoms that may be linked to accumulation of noble metals or other conductive material on the melter floor. During the time period from July 2000 to December 2000, the monthly average ratio of upper-to-lower melt apparent resistance increased from 1.02 to 1.60. The ratio has stayed between 1.30 and 1.60 during all of 2001 (*Note*: This data was last updated for this report on July 12, 2001). This is shown in Figure 7-1.

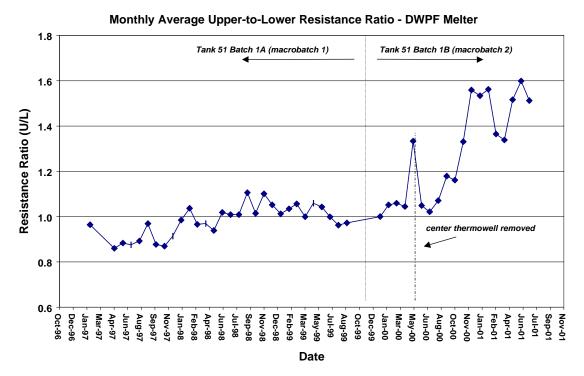


Figure 7-1. Monthly Average Upper-to-Lower Resistance Ratio – DWPF Meler

The apparent shift has been found to be the result of electrical shorting outside of the melter and has been restored to the previous condition. In November 1999, a new sludge macrobatch (Tank 51 sludge 1B, macrobatch 2) was introduced. This sludge was higher in aluminum than the previous macrobatch had been. This resulted in a more viscous molten glass and possibly less convection in the melter. Also, in May 2000 a thermowell with three thermocouples was removed from the center of the melter (measuring the lower glass pool temperature). The average lower glass pool temperature abruptly dropped at that time since it was then the average of only three thermocouple readings in a thermowell located near the outer edge of the melter wall (a colder region of the melt pool). So, the change in the resistance ratio is, at least partially, due to this artificial drop in the lower glass temperature (and a corresponding increase in the upper glass temperature). Prior to May 2000, the average lower glass pool temperature, which at that time was an average of six thermocouple readings (three in the center of the melter and three at the outer

edge of the melt pool), consistently ran from 1100 to 1120 °C. The average upper glass pool temperature was typically between 1140 and 1170 °C. However, after May 2000, the monthly average temperature (of just the three outer edge thermocouple readings) for the lower glass pool has ranged from 1060 to 1080 °C. Average monthly upper and lower glass pool resistances are shown in Figure 7-2. Average monthly upper and lower glass pool temperatures are shown in Figure 7-3. This apparent decrease in temperature may be real or it may be an artifact of reduced information on the temperature of the melter. It increases the risk that localized overheating can occur.

In the early periods of radioactive operation, the amount of current supplied to the upper set of electrodes was typically nearly the same or slightly more than that supplied to the lower set (sometimes as much as 25% more). In June 2000 the amount of current supplied to the respective electrodes began to diverge, increasing from 916 to 1226 amps for the lower electrodes and decreasing from 923 to 729 amps for the upper electrodes (monthly averages between June 2000 and July 2001). This is shown in Figure 7-4. The ratio of upper-to-lower electrode current is shown in Figure 7-5. There has been a consistent downward trend in this measure. The lower electrodes were provided with approximately 40% more current than that provided to the upper electrodes. It has been determined that this was not the real power dissipated by the electrodes: An unknown proportion of it was lost to an electrical short outside of the melter. The data for all of these figures (Figures 7-1 through 7-5) are provided in Table 7-1.

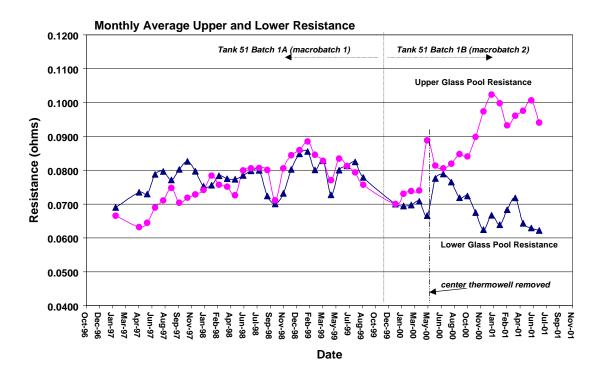


Figure 7-2. Monthly Average Upper and Lower Glass Pool Resistances

Average Upper and Lower Glass Pool Temps (deg C)

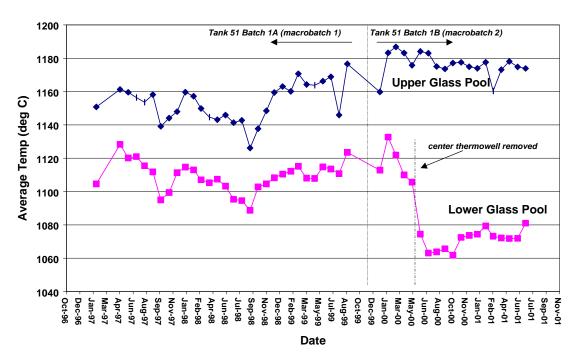


Figure 7-3. Monthly Average Upper and Lower Glass Pool Temperature

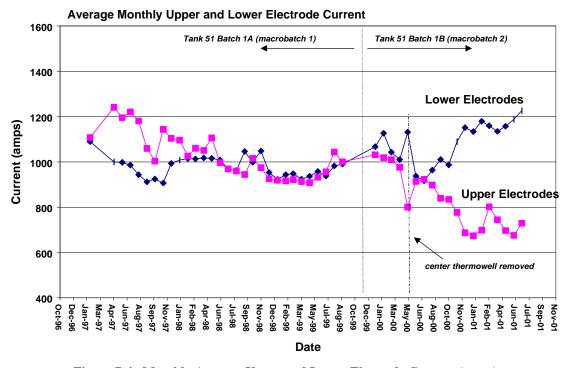


Figure 7-4. Monthly Average Upper and Lower Electrode Current (amps)

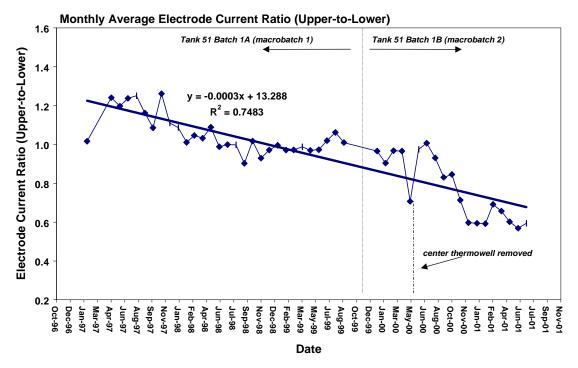


Figure 7-5. Monthly Average Electrode Current Ratio (Upper-to-Lower)

All of these events are consistent with observations made during the operation of the IDMS melter. Similar to that observed in the DWPF, the resistance ratio for the IDMS melter was initially stable, oscillating from 1.1 to 1.3. However, after 550 days of operation with noble metals the resistance ratio increased dramatically and continued upward, over time, to 2.3 - 2.5. The sudden increase in the resistance ratio corresponded to a time when melter floor samples revealed a significant increase in the amount of material on the melter floor. Upon close examination of the date (plots are presented in Smith and Bickford, 1997), it appears that the IDMS upper-to-lower resistance ratio increased largely because of an increase in the apparent resistance in the upper glass pool. The lower glass pool resistance did have a gradual drop during a 100-day period of operation (during days 500 to 600 of operation) when the lower glass pool resistance declined from the nominal 0.10 ohms to about 0.06 ohms. It remained at about 0.06 to 0.07 ohms for the remainder of the operation. The upper glass pool resistance also declined during the same 100-day period, from the initial 0.12 down to about 0.10. It then decreased to about 0.08 before beginning a steady increase up to approximately 0.15 ohms. In contrast, the DWPF melter has not had a sustained decrease in the lower melt pool resistance.

Eventually, due to the accumulation of conductive material, a computed lower electrode current density of approximately 6.1 amps/in² (compared to the design value of 5.0 amps/in²) was required to maintain the lower glass pool at 1070°C. This was not the actual loading, however, because of indeterminate parasitic losses from the bus bar

shorting. The DWPF lower electrode current density is now below 3.0 amps/in² and has not exceeded the design value (although non-uniform firing can lead to localized areas of high current density).

Table 7-1. Monthly Average Operational Parameters for the DWPF Melter

Lower Comms Comm	Date]	Resistance		Glass	Pool Temper	ature	Elec	ctrode Curren	ţ
Feb-97		Lower	Upper	Ratio		_		Lower	Upper	Ratio
May-97		Ohms	Ohms	U/L			U/L	Amps	Amps	U/L
May-97	Feb-97	0.0690	0.0665	0.964	1150.8	1104.6	1.042	1089.70	1107.94	1.017
Jun-97				0.860						1.241
Jul-97	•					1120.2		998.27		1.197
Aug. 97			0.0690							1.238
Sep-97 0.0771 0.0748 0.969 1158.2 1111.8 1.042 912.25 1059.92 1. Oct-97 0.0802 0.0704 0.877 1139.1 1095.0 1.040 924.35 1003.74 1. Nov-97 0.0826 0.0719 0.870 1144.1 1099.4 1.041 906.65 1143.85 1. Dec-97 0.0797 0.0728 0.914 1148.0 1111.3 1.030 193.46 1103.91 1. Jan-98 0.0753 0.0741 0.985 1159.6 1114.7 1.040 1004.92 1026.04 1. Mar-98 0.0753 0.0757 0.966 1149.9 1107.1 1.040 1014.92 1026.04 1. Mar-98 0.0773 0.0726 0.939 1143.1 1107.4 1.032 1015.94 1106.42 1. Jul-98 0.0780 0.0790 1.041.4 1095.3 1.042 969.75 969.26 0. Aug-98	Aug-97								1180.70	1.251
Oct-97 0.0802 0.0704 0.877 1139.1 1095.0 1.040 924.35 1003.74 1. Dec-97 0.0826 0.0719 0.870 1144.1 1099.4 1.041 906.65 1143.85 1. Dec-97 0.0757 0.0753 0.0741 0.985 1159.6 1111.3 1.033 993.46 1103.91 1. Jan-98 0.0753 0.0741 0.985 1159.6 1111.7 1.040 1008.47 1096.04 1. Mar-98 0.0753 0.0751 0.970 1144.7 1105.3 1.036 1017.70 1050.11 1.039 1013.31 1060.44 1. Apr-98 0.0775 0.0751 0.970 1144.7 1105.3 1.036 1017.70 1050.14 1. 105.01 1. 105.01 1. 105.01 1. 105.01 1. 105.01 1. 1105.01 111.01 1105.01 112.01 1105.3 1.032 1015.94 106.21 96.22		0.0771		0.969				912.25		1.162
Nov-97										1.086
Dec-97										1.262
Jan-98										1.111
Feb-98										1.087
Mar-98 0.0783 0.0757 0.966 1149.9 1107.1 1.039 1013.31 1060.44 1. Apr-98 0.0775 0.0751 0.970 1144.7 1105.3 1.036 1017.70 1050.71 1. May-98 0.0778 0.0795 0.0791 1143.1 1107.4 1.032 1015.94 1106.42 1. Jun-98 0.0785 0.0799 1.019 1145.9 1103.3 1.039 1008.33 996.79 0. Jun-98 0.0806 1.009 1141.4 1095.3 1.042 969.75 969.26 0. Aug-98 0.0800 0.0807 1.009 1141.4 1095.3 1.042 969.75 969.26 0.02 960.28 0.0802 90.0801 1.106 1126.1 1088.7 1.034 1046.31 944.57 0.0 0.0722 0.0722 0.0722 0.0802 0.0801 1.105 1137.7 1102.8 1.032 998.47 1015.98 1. 1.046 953.32 926.03 0.0 962.03 0.0 962.03 0.0 974.85										1.011
Apr-98 0.0775 0.0751 0.970 1144.7 1105.3 1.036 1017.70 1050.71 1. May-98 0.07773 0.0726 0.939 1143.1 1107.4 1.032 1015.94 1106.42 1. Jun-98 0.0788 0.0806 1.009 1141.4 1095.3 1.042 969.75 969.26 0. Aug-98 0.0800 0.0807 1.009 1142.8 1094.5 1.044 962.12 960.28 0. Oct-98 0.0701 0.0711 1.016 1126.1 1088.7 1.034 1046.31 944.57 0. Nov-98 0.0732 0.0805 1.101 1148.4 1104.6 1.040 1048.55 974.85 0. Dec-98 0.0802 0.0844 1.052 1159.5 1108.3 1.046 953.32 926.03 0. Feb-99 0.0855 0.0855 1.035 1160.1 1112.2 1.043 943.72 916.53 0.										1.047
May-98 0.0773 0.0726 0.939 1143.1 1107.4 1.032 1015.94 1106.42 1. Jun-98 0.0785 0.0799 1.019 1145.9 1103.3 1.039 1008.33 996.79 0.080 Jul-98 0.0800 0.0807 1.009 1142.8 1094.5 1.044 962.12 969.26 0. Sep-98 0.0704 0.0801 1.106 1126.1 1088.7 1.034 1046.31 944.57 0. Oct-98 0.0701 0.0711 1.015 1137.7 1102.8 1.032 998.47 1015.98 1. Nov-98 0.0732 0.0805 1.101 1148.4 1104.6 1.040 1048.55 974.85 0. Dec-98 0.0802 0.0844 1.052 1159.5 1108.3 1.046 953.32 926.03 0. Feb-99 0.0885 1.033 1163.0 1110.5 1.047 922.88 19.08 0. Mar-99										1.032
Jun-98 0.0785 0.0799 1.019 1145.9 1103.3 1.039 1008.33 996.79 0. Jul-98 0.0798 0.0806 1.009 1141.4 1095.3 1.042 969.75 969.26 0. Aug-98 0.0800 0.0801 1.006 1126.1 1088.7 1.034 1046.31 944.57 0. Oct-98 0.0701 0.0711 1.015 1137.7 1102.8 1.032 998.47 1015.98 1. Nov-98 0.0732 0.0805 1.101 1148.4 1104.6 1040 1048.55 974.85 0. Dec-98 0.0802 0.0844 1.052 1159.5 1108.3 1.046 953.32 926.03 0. Jan-99 0.0849 0.0859 1.013 1163.0 1110.5 1.047 922.88 919.08 0. Feb-99 0.0855 0.0885 1.035 1160.1 1112.2 1.043 943.72 916.53 0.										1.089
Jul-98	•									0.989
Aug-98 0.0800 0.0807 1.009 1142.8 1094.5 1.044 962.12 960.28 0.028 Sep-98 0.0724 0.0801 1.106 1126.1 1088.7 1.034 11046.31 944.57 0.071 Nov-98 0.0732 0.0805 1.101 1148.4 1104.6 1.040 1048.55 974.85 0.0802 Dec-98 0.0802 0.0844 1.052 1159.5 1108.3 1.046 953.32 926.03 0.081 Jan-99 0.0849 0.0859 1.013 1163.0 1110.5 1.047 922.88 919.08 0.086 Feb-99 0.0855 0.0885 1.035 1160.1 1112.2 1.043 943.72 916.53 0.0 Mar-99 0.0828 0.0828 1.035 1160.1 1112.2 1.043 943.77 921.84 0.0 May-99 0.0828 0.0828 1.000 1164.3 1108.0 1.051 924.06 913.20 0.0 <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td></td> <td>0.999</td>										0.999
Sep-98 0.0724 0.0801 1.106 1126.1 1088.7 1.034 1046.31 944.57 0. Oct-98 0.0701 0.0711 1.015 1137.7 1102.8 1.032 998.47 1015.98 1. Nov-98 0.0732 0.0805 1.101 1148.4 1104.6 1.040 1048.55 974.85 0. Dec-98 0.0802 0.0844 1.052 1159.5 1108.3 1.046 953.32 926.03 0. Jan-99 0.0849 0.0855 1.035 1160.1 1112.2 1.043 943.72 916.53 0. Mar-99 0.0801 0.0846 1.056 1170.7 1115.1 1.050 948.37 921.84 0. May-99 0.0727 0.0770 1.059 1163.8 1107.8 1.051 936.90 908.38 0. Jul-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0.										0.998
Oct-98 0.0701 0.0711 1.015 1137.7 1102.8 1.032 998.47 1015.98 1. Nov-98 0.0732 0.0805 1.101 1148.4 1104.6 1.040 1048.55 974.85 0. Dec-98 0.0802 0.0844 1.052 1159.5 1108.3 1.046 953.32 926.03 0. Jan-99 0.0849 0.0859 1.013 1163.0 1110.5 1.047 922.88 919.08 0. Feb-99 0.0855 0.0885 1.035 1160.1 1112.2 1.043 943.72 916.53 0. Mar-99 0.0801 0.0846 1.056 1170.7 1115.1 1.050 948.37 921.84 0. Apr-99 0.0828 0.0828 1.000 1164.3 1108.0 1.051 936.90 908.38 0. Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. <										0.903
Nov-98 0.0732 0.0805 1.101 1148.4 1104.6 1.040 1048.55 974.85 0. Dec-98 0.0802 0.0844 1.052 1159.5 1108.3 1.046 953.32 926.03 0. Jan-99 0.0849 0.0855 1.035 1160.1 1112.2 1.043 943.72 916.53 0. Mar-99 0.0801 0.0846 1.056 1170.7 1115.1 1.050 948.37 921.84 0. Apr-99 0.0828 0.0828 1.000 1164.3 1108.0 1.051 924.06 913.20 0. May-99 0.0777 0.0770 1.059 1163.8 1107.8 1.051 936.90 908.38 0. Jul-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. <t< td=""><td>-</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td>1.018</td></t<>	-									1.018
Dec-98 0.0802 0.0844 1.052 1159.5 1108.3 1.046 953.32 926.03 0. Jan-99 0.0849 0.0859 1.013 1163.0 1110.5 1.047 922.88 919.08 0. Feb-99 0.0855 0.0885 1.035 1160.1 1112.2 1.043 943.72 916.53 0. Mar-99 0.0801 0.0846 1.056 1170.7 1115.1 1.050 948.37 921.84 0. Apr-99 0.0828 0.0828 1.000 1164.3 1108.0 1.051 936.90 908.38 0. Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. <th< td=""><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td>0.930</td></th<>										0.930
Jan-99 0.0849 0.0859 1.013 1163.0 1110.5 1.047 922.88 919.08 0. Feb-99 0.0855 0.0885 1.035 1160.1 1112.2 1.043 943.72 916.53 0. Mar-99 0.0801 0.0846 1.056 1170.7 1115.1 1.050 948.37 921.84 0. Apr-99 0.0828 0.0828 1.000 1164.3 1108.0 1.051 924.06 913.20 0. May-99 0.0727 0.0770 1.059 1163.8 1107.8 1.051 936.90 908.38 0. Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. Aug-99 0.0824 0.0793 0.962 1145.9 1110.8 1.032 982.61 1043.44 1. <t< td=""><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td>0.971</td></t<>										0.971
Feb-99 0.0855 0.0885 1.035 1160.1 1112.2 1.043 943.72 916.53 0. Mar-99 0.0801 0.0846 1.056 1170.7 1115.1 1.050 948.37 921.84 0. Apr-99 0.0828 0.000 1164.3 1108.0 1.051 924.06 913.20 0. May-99 0.0777 0.0770 1.059 1163.8 1107.8 1.051 936.90 908.38 0. Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. Aug-99 0.0824 0.0793 0.962 1145.9 1110.8 1.032 982.61 1043.44 1. Sep-99 0.0779 0.0757 0.972 1176.6 1123.5 1.047 991.01 1000.67 1. Jan-00 <										0.996
Mar-99 0.0801 0.0846 1.056 1170.7 1115.1 1.050 948.37 921.84 0.0 Apr-99 0.0828 0.0828 1.000 1164.3 1108.0 1.051 924.06 913.20 0. May-99 0.0727 0.0770 1.059 1163.8 1107.8 1.051 936.90 908.38 0. Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. Aug-99 0.0824 0.0793 0.962 1145.9 1110.8 1.032 982.61 1043.44 1. Sep-99 0.0779 0.0757 0.972 1176.6 1123.5 1.047 991.01 1000.67 1. Jan-00 0.0700 0.0700 1.000 1159.8 1112.9 1.042 1067.50 1031.58 0.										0.971
Apr-99 0.0828 0.0828 1.000 1164.3 1108.0 1.051 924.06 913.20 0.0 May-99 0.0727 0.0770 1.059 1163.8 1107.8 1.051 936.90 908.38 0. Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. Aug-99 0.0824 0.0793 0.962 1145.9 1110.8 1.032 982.61 1043.44 1. Sep-99 0.0779 0.0757 0.972 1176.6 1123.5 1.047 991.01 1000.67 1. Jan-00 0.0700 0.0700 1.000 1159.8 1112.9 1.042 1067.50 1031.58 0. Feb-00 0.0694 0.0730 1.052 1183.2 1132.7 1.045 1126.69 1018.95 0.										0.972
May-99 0.0727 0.0770 1.059 1163.8 1107.8 1.051 936.90 908.38 0. Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. Aug-99 0.0824 0.0793 0.962 1145.9 1110.8 1.032 982.61 1043.44 1. Sep-99 0.0779 0.0757 0.972 1176.6 1123.5 1.047 991.01 1000.67 1. Jan-00 0.0700 0.0700 1.000 1159.8 1112.9 1.042 1067.50 1031.58 0. Feb-00 0.0694 0.0730 1.052 1183.2 1132.7 1.045 1126.69 1018.95 0. Mar-00 0.0697 0.0738 1.059 1186.9 1122.0 1.058 1043.24 1010.26 0.										0.988
Jun-99 0.0800 0.0834 1.043 1166.2 1114.8 1.046 958.23 932.09 0. Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. Aug-99 0.0824 0.0793 0.962 1145.9 1110.8 1.032 982.61 1043.44 1. Sep-99 0.0779 0.0757 0.972 1176.6 1123.5 1.047 991.01 1000.67 1. Jan-00 0.0700 0.0700 1.000 1159.8 1112.9 1.042 1067.50 1031.58 0. Feb-00 0.0694 0.0730 1.052 1183.2 1132.7 1.045 1126.69 1018.95 0. Mar-00 0.0697 0.0738 1.059 1186.9 1122.0 1.058 1043.24 1010.26 0. May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0.										0.970
Jul-99 0.0813 0.0812 0.999 1168.9 1113.6 1.050 937.97 956.71 1. Aug-99 0.0824 0.0793 0.962 1145.9 1110.8 1.032 982.61 1043.44 1. Sep-99 0.0779 0.0757 0.972 1176.6 1123.5 1.047 991.01 1000.67 1. Jan-00 0.0700 0.0700 1.000 1159.8 1112.9 1.042 1067.50 1031.58 0. Feb-00 0.0694 0.0730 1.052 1183.2 1132.7 1.045 1126.69 1018.95 0. Mar-00 0.0697 0.0738 1.059 1186.9 1122.0 1.058 1043.24 1010.26 0. Apr-00 0.0708 0.0740 1.045 1183.2 1110.0 1.066 1010.11 976.16 0. May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0.	•									0.973
Aug-99 0.0824 0.0793 0.962 1145.9 1110.8 1.032 982.61 1043.44 1. Sep-99 0.0779 0.0757 0.972 1176.6 1123.5 1.047 991.01 1000.67 1. Jan-00 0.0700 0.0700 1.000 1159.8 1112.9 1.042 1067.50 1031.58 0. Feb-00 0.0694 0.0730 1.052 1183.2 1132.7 1.045 1126.69 1018.95 0. Mar-00 0.0697 0.0738 1.059 1186.9 1122.0 1.058 1043.24 1010.26 0. Apr-00 0.0708 0.0740 1.045 1183.2 1110.0 1.066 1010.11 976.16 0. May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0. Jul-00 0.0776 0.0814 1.049 1184.1 1074.5 1.102 937.33 913.75 0.										1.020
Sep-99 0.0779 0.0757 0.972 1176.6 1123.5 1.047 991.01 1000.67 1. Jan-00 0.0700 0.0700 1.000 1159.8 1112.9 1.042 1067.50 1031.58 0. Feb-00 0.0694 0.0730 1.052 1183.2 1132.7 1.045 1126.69 1018.95 0. Mar-00 0.0697 0.0738 1.059 1186.9 1122.0 1.058 1043.24 1010.26 0. Apr-00 0.0708 0.0740 1.045 1183.2 1110.0 1.066 1010.11 976.16 0. May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0. Jul-00 0.0776 0.0814 1.049 1184.1 1074.5 1.102 937.33 913.75 0. Jul-00 0.0789 0.0806 1.021 1183.1 1063.1 1.113 916.84 923.03 1.										1.062
Jan-00 0.0700 0.0700 1.000 1159.8 1112.9 1.042 1067.50 1031.58 0. Feb-00 0.0694 0.0730 1.052 1183.2 1132.7 1.045 1126.69 1018.95 0. Mar-00 0.0697 0.0738 1.059 1186.9 1122.0 1.058 1043.24 1010.26 0. Apr-00 0.0708 0.0740 1.045 1183.2 1110.0 1.066 1010.11 976.16 0. May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0. Jun-00 0.0776 0.0814 1.049 1184.1 1074.5 1.102 937.33 913.75 0. Jul-00 0.0789 0.0806 1.021 1183.1 1063.1 1.113 916.84 923.03 1. Aug-00 0.0765 0.0819 1.071 1175.1 1063.8 1.105 964.15 897.55 0.										1.010
Feb-00 0.0694 0.0730 1.052 1183.2 1132.7 1.045 1126.69 1018.95 0. Mar-00 0.0697 0.0738 1.059 1186.9 1122.0 1.058 1043.24 1010.26 0. Apr-00 0.0708 0.0740 1.045 1183.2 1110.0 1.066 1010.11 976.16 0. May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0. Jun-00 0.0776 0.0814 1.049 1184.1 1074.5 1.102 937.33 913.75 0. Jul-00 0.0789 0.0806 1.021 1183.1 1063.1 1.113 916.84 923.03 1. Aug-00 0.0765 0.0819 1.071 1175.1 1063.8 1.105 964.15 897.55 0. Sep-00 0.0719 0.0847 1.179 1173.6 1065.7 1.101 1010.87 839.53 0.										0.966
Mar-00 0.0697 0.0738 1.059 1186.9 1122.0 1.058 1043.24 1010.26 0. Apr-00 0.0708 0.0740 1.045 1183.2 1110.0 1.066 1010.11 976.16 0. May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0. Jun-00 0.0776 0.0814 1.049 1184.1 1074.5 1.102 937.33 913.75 0. Jul-00 0.0789 0.0806 1.021 1183.1 1063.1 1.113 916.84 923.03 1. Aug-00 0.0765 0.0819 1.071 1175.1 1063.8 1.105 964.15 897.55 0. Sep-00 0.0719 0.0847 1.179 1173.6 1065.7 1.101 1010.87 839.53 0. Oct-00 0.0724 0.0841 1.161 1177.1 1061.8 1.109 986.91 834.61 0.										0.904
Apr-00 0.0708 0.0740 1.045 1183.2 1110.0 1.066 1010.11 976.16 0. May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0. Jun-00 0.0776 0.0814 1.049 1184.1 1074.5 1.102 937.33 913.75 0. Jul-00 0.0789 0.0806 1.021 1183.1 1063.1 1.113 916.84 923.03 1. Aug-00 0.0765 0.0819 1.071 1175.1 1063.8 1.105 964.15 897.55 0. Sep-00 0.0719 0.0847 1.179 1173.6 1065.7 1.101 1010.87 839.53 0. Oct-00 0.0724 0.0841 1.161 1177.1 1061.8 1.109 986.91 834.61 0. Nov-00 0.0675 0.0898 1.331 1177.5 1072.4 1.098 1089.70 777.30 0.										0.968
May-00 0.0666 0.0888 1.334 1175.8 1105.7 1.063 1131.53 800.47 0. Jun-00 0.0776 0.0814 1.049 1184.1 1074.5 1.102 937.33 913.75 0. Jul-00 0.0789 0.0806 1.021 1183.1 1063.1 1.113 916.84 923.03 1. Aug-00 0.0765 0.0819 1.071 1175.1 1063.8 1.105 964.15 897.55 0. Sep-00 0.0719 0.0847 1.179 1173.6 1065.7 1.101 1010.87 839.53 0. Oct-00 0.0724 0.0841 1.161 1177.1 1061.8 1.109 986.91 834.61 0. Nov-00 0.0675 0.0898 1.331 1177.5 1072.4 1.098 1089.70 777.30 0. Dec-00 0.0624 0.0973 1.559 1174.9 1073.7 1.094 1151.40 687.57 0.										0.966
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Apr-01 0.0718 0.0961 1.338 1173.2 1072.2 1.094 1134.76 745.28 0.										0.692
										0.657
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										0.569
										0.595

7.2 Future Tank Wastes

The DWPF has been in radioactive operation since 1996 and will soon begin feeding a new sludge with concentrations of noble metals that are higher than have been processed to date. Table 7-2 gives the predicted noble metal concentrations for HM, PUREX and Blend sludges (a hypothetical blending of PUREX and HM). Also listed are measured values for Tank 51-1A (sludge batch 1A, macrobatch 1) and for Tank 40, the next sludge batch to the DWPF. The values for Tank 40 represent the maximum (overwashed) and minimum (as received) bounding values for these components (Fellinger and Bibler, 2001). The values for Tank 40 indicate a significant increase in the expected values of Ru and Rh (the noble metals that tend to be retained in the melter in the highest percentages) over that of Tank 51-1A. The Rh concentration is 5 to 10 times higher in Tank 40 than in Tank 51-1A. (*Note:* The concentration of each depends on the degree of washing. The SRS sludge is washed to remove excess aluminum and sodium. The lower value represents the "no washing" extreme and the upper value represents the "overwashed" extreme).

Table 7-2. Predicted and Measured Noble Metal Concentrations in Various Savannah River Sludges

	Blend	HM	PUREX	Tank 51	Tank 40 Measured	
	Predicted	Predicted	Predicted	Measured	(as received)	(overwashed)
Element	wt-%	wt-%	wt-%	wt-%	wt-%	wt-%
Ru	0.100	0.217	0.028	0.007	0.019	0.042
Rh	0.018	0.038	0.008	0.001	0.005	0.010
Pd	0.045	0.079	0.026	0.006	0.001	0.001
Ag	0.014	0.014	0.014	0.014	0.007	0.015

(wt-% of the total sludge solids, soluble and insoluble)

The SRS Tank 51 sludge that has been fed to the DWPF melter has been very low in noble metals (concentration), much lower than was tested in the IDMS melter (see Table 1-1). The melter has experienced relatively few periods of extended idling. And now the DWPF is preparing to begin processing of a new batch of sludge that is much higher in noble metals. Most studies have indicated that the amount of noble metals that settle to the melter floor is greatly influenced by: 1) the concentration of the noble metals in the melt, 2) the size, shape and chemical state of the noble metals including the adjacent material, and 3) the amount of mixing in the melter. The next sludge batch, from SRS Tank 40, is 2.7 to 6 times higher in Ru than that of Tank 51-1A (Tank 51 sludge 1A, macrobatch 1). The Rh concentration is 5 to 10 times higher in Tank 40 than in Tank 51-1A. *Note:* The concentration of each depends on the degree of washing. The SRS sludge is washed to remove excess aluminum and sodium. The lower value represents the "no washing" extreme and the upper value represents the "overwashed" extreme. In Research Scale Melter (RSM) studies at PNNL, the results suggested that there was a significant nonlinear increase in the amount of noble metal compounds deposited on the melter floor. With a 2-fold increase in the nominal noble metal content of the NCAW melter feed simulant there was a corresponding 9-fold increase in the fraction settling to the RSM floor (Cooper *et al.*, 1994). The NCAW noble metals content is much closer to that of the SRS HM sludge, which is much higher than will be processed from Tank 40. So, the amount of noble metals that settle from that glass melt may not be 9-fold over that

from Tank 51-1A, but, it is likely that there will be some nonlinear increase in noble metals settling from Tank 40 melter feed over than from the Tank 51-1A melter feed.

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